

# R1Q3A7236ABB R1Q3A7218ABB

72-Mbit QDR™II SRAM 4-word Burst

R10DS0165EJ0011 Rev. 0.11 2013.01.15

#### Description

The R1Q3A7236 is a 2,097,152-word by 36-bit and the R1Q3A7218 is a 4,194,304-word by 18-bit synchronous quad data rate static RAM fabricated with advanced CMOS technology using full CMOS six-transistor memory cell. It integrates unique synchronous peripheral circuitry and a burst counter. All input registers are controlled by an input clock pair (K and /K) and are latched on the positive edge of K and /K. These products are suitable for applications which require synchronous operation, high speed, low voltage, high density and wide bit configuration. These products are packaged in 165-pin plastic FBGA package.

#### Features

- Power Supply
  - 1.8 V for core (V<sub>DD</sub>), 1.4 V to V<sub>DD</sub> for I/O (V<sub>DDQ</sub>)
- Clock
  - Fast clock cycle time for high bandwidth
  - Two input clocks (K and /K) for precise DDR timing at clock rising edges only
  - Two input clocks for output data (C and /C) to minimize clock skew and flight time mismatches
  - Two output echo clocks (CQ and /CQ) simplify data capture in high-speed systems
  - Clock-stop capability with µs restart
- I/O
  - Separate independent read and write data ports with concurrent transactions
  - 100% bus utilization DDR read and write operation
  - HSTL I/O
  - User programmable output impedance
  - DLL/PLL circuitry for wide output data valid window and future frequency scaling
- Function
  - · Four-tick burst for reduced address frequency
  - Internally self-timed write control
  - Simple control logic for easy depth expansion
  - JTAG 1149.1 compatible test access port
- Package
  - 165 FBGA package (13 x 15 x 1.4 mm)
- Notes: 1. QDR RAMs and Quad Data Rate RAMs comprise a new family of products developed by Cypress Semiconductor, IDT, Samsung, and Renesas Electronics Corp. (QDR Co-Development Team)
  - 2. The specifications of this device are subject to change without notice. Please contact your nearest Renesas Electronics Sales Office regarding specifications.
  - Refer to "http://www.renesas.com/products/memory/fast\_sram/qdr\_sram/index.jsp" for the latest and detailed information.
  - 4. Descriptions about x9 parts in this datasheet are just for reference.



#### **Part Number Definition**

Column No.	0	1	2	3	4	5	6	7	8	9	10	11	-	12	13	14	15	16
Example	R	1	Q	3	Α	7	2	1	8	Α	В	в	-	3	0	R	В	0
Example	The	e abov	/e parl	t numt	oer is j	ust ex	ample	e for 72	2M QE	DRII B	4 x18	333M	Hz, 13	3x15m	m PK	G, Pb-	free p	art.

No.	-	Comments	No.	-	Comments	No.	-	Comments		
0-1	R1	Renesas Memory Prefix	4	A	Vdd = 1.8 V		60	Frequency = 167MHz		
	Q2	QDR II B2 <sup>[*1]</sup> (L15) <sup>[*2]</sup>		36	Density = 36Mb	1	50	Frequency = 200MHz		
	Q3	QDR    B4 (L15)	5-6	72	Density = 72Mb		40	Frequency = 250MHz		
	Q4	DDR II B2 (L15)	5-6	44	Density = 144Mb		36	Frequency = 275MHz		
	Q5	DDR II B4 (L15)		88	Density = 288Mb		33	Frequency = 300MHz		
	Q6	DDR II B2 SIO <sup>[*3]</sup> (L15)		09	Data width = 9bit	12-13	30	Frequency = 333MHz		
	QA	QDR II+ B4 L25 <sup>[*2]</sup>	7-8	18	Data width = 18bit	12-13	27	Frequency = 375MHz		
	QB	DDR IH B2 L25		36	Data width = 36bit		25	Frequency = 400MHz		
	QC	DDR II+ B4 L25		R	1st Generation	]	22	Frequency = 450MHz		
	QD	QDR II+ B4 L25 w/ODT <sup>[*4]</sup>		A	2nd Generation		20	Frequency = 500MHz		
	QE	DDR II+ B2 L25 w/ODT		В	3rd Generation		19	Frequency = 533MHz		
2-3	QF	DDR II+ B4 L25 w/ODT	9	С	4th Generation	1	18	Frequency = 550MHz		
	QG	QDR II+ B4 L20		D	5th Generation		R	Commercial temp.		
	QH	DDR II+ B2 L20		E	6th Generation	14	n	Ta range = 0° <b>C</b> to 70° <b>C</b>		
	QJ	DDR II+ B4 L20		F	7th Generation	14	1	Industrial temp.		
	QK	QDR II+ B4 L20 w/ODT	10-11	BG	PKG= BGA 15x17 mm		1	Ta range = -40℃ to 85℃		
	QL	DDR II+ B2 L20 w/ODT	10-11	BB	PKG= BGA 13x15 mm		A	Pb and Tray		
	QM	DDR II+ B4 L20 w/ODT				15	В	Pb-free and Tray		
	QN	QDR II+ B2 L20					Т	Pb and Tape&Reel		
	QP	QDR II+ B2 L20 w/ODT	_		_		S	Pb-free and Tape&Reel		
			_	- I	-		0 to 9,			
	-	-				16	A to Z	Renesas internal use		
							or None			
Note1:		[*1] B=Burst length (B2: Burst length [*2] L=Read Latency (L15: Read Latency (L15: Read Latency (L15: Read Latency (*3) SIO=Separate I/O [*4] ODT=On die termination				)				
Note2:	Package Marking Name Pb parts: Marking Name = Part Number(0-14) Pb-free parts: Marking Name = Part Number(0-14) + "PB-F" (Example) R1QAA4436RBG-20R Pb parts R1QAA4436RBG-20R PB-F Pb-free parts									
Note3:		Pb : RoHS Compliance Level = Pb-free: RoHS Compliance Level =								
Note4:		R1Q*A series support both "Commo by "Industrial" temperature parts.	ercial" and	"Industria	l" temperatures					



## 72M QDR/DDR SRAM (R1Q\*A72 Series) Lineup

- Renesas supports or plans to support the parts listed below.

No         Trequency (max) (MHz)         533         500         450         400         375         333         333         300         250         200           No         Total Section 1         Total Section 1 <td< th=""><th></th><th></th><th></th><th></th><th></th><th></th><th></th><th colspan="2">Г</th><th></th><th></th><th></th><th></th><th></th><th colspan="5">QDR II / DDR II</th></td<>								Г							QDR II / DDR II				
No       No <t< td=""><td></td><td></td><td></td><td></td><td></td><td></td><td><b>F</b></td><td></td><td></td><td>Q</td><td></td><td></td><td>11-</td><td></td><td>, i</td><td></td><td>DDR</td><td></td></t<>							<b>F</b>			Q			11-		, i		DDR		
Image: constraint of the second sec		e e	lth st	lcy le)	⊢	i n	(MHz)		533	500	450	400	375	333	333	300	250	200	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	No	Prod Typ	Bur Leng	Later (Cyc	O	Orga zatic		nin)	1.875	2.00	2.22	2.50	2.66	3.00	3.00	3.30	4.00	5.00	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $							Part Number 🖡	уу →	-19	-20	-22	-25	-27	-30	-30	-33	-40	-50	
3       QORII       40       50         5       0       33       6 (Q 2 A72 36 A B v- yy)	1					x 9	R1Q 2 A72 09 A B	v-yy									-40	-50	
3       QORII       40       50         5       0       33       6 (Q 2 A72 36 A B v- yy)	2		B2			x18	R1Q 2 A72 18 A B	v-yy									40	50	
6       84       9       13       14       13       14         8       9       DDRII       82       13       R1Q 4 A72 36 A Bv- yy       33       40         11       12       13       84       13       R1Q 4 A72 36 A Bv- yy       33       40         14       DDRII       B4       24       13       R1Q 4 A72 36 A Bv- yy       33       40         14       DDRII       B2       50       B2       51       13       R1Q 5 A72 36 A Bv- yy       33       40         15       SIO       B2       51       18       R1Q 6 A72 36 A Bv- yy       -19       -20       -22       -30       -33       40         17       QDRII+       B4       51       51       81       R1Q A A72 36 A Bv- yy       -19       -20       -22       -22         20       21       24       18       R1Q A A72 36 A Bv- yy       -19       -20       -22       -22         20       21       24       18       R1Q A A72 36 A Bv- yy       -19       -20       -22       -22         21       23       24       18       R1Q A A72 36 A Bv- yy       -19       -20       -22       -22	3	QDRII				x36	R1Q 2 A72 36 A B	v-yy									-40	-50	
6       -			D4			x18	R1Q 3 A72 18 A B	v-yy							20	22	40		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			D4												-30	-33	-40		
9       DDRII       4         11       DDRII       84         11       DDRII       84         12       N38       RIQ 5 A72 18 A Bv- yy	8		<b>D</b> 2	1.5	No	x18	R1Q 4 A72 18 A B	v- yy							20	22	40		
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12       12       12       13       14       DDRII       14       DDRII       15       13       R1Q 6 A72 18 A Bv- yy       -30       -30       -33       -40         14       DDRII       B4       12       18       R1Q 6 A72 18 A Bv- yy       -19       -20       -22       -30       -33       -40         17       QDRII+       B4       12       18       R1Q 6 A72 18 A Bv- yy       -19       -20       -22		DUKI	R4												-20	22	_10		
14       DDRII       B2       x18       R1Q 6 A72 18 A Bv- yy x36       x36       R1Q 6 A72 18 A Bv- yy x36       x36       R1Q 6 A72 36 A Bv- yy x36       x36       R1Q A A72 36 A Bv-			D4			x36	R1Q 5 A72 36 A B	v- yy							-30	-33	-40		
15       SIO       x36       R1Q 6 A72 36 AByy       -22         17       QDRII+       B4       x36       R1Q A A72 18 AByy       -19       -20       -22         20       DDRII+       B4       x36       R1Q A A72 36 ABv-yy       -19       -20       -22         23       DDRII+       B4       x36       R1Q A A72 36 ABv-yy       -19       -20       -22         26       QDRII+       B4       x36       R1Q C A72 36 ABv-yy       -19       -20       -22         26       QDRII+       B4       x36       R1Q C A72 36 ABv-yy       -19       -20       -22         27       QDRII+       B4       x36       R1Q C A72 36 ABv-yy       -19       -20       -22         28       QDRII+       B4       x18       R1Q C A72 36 ABv-yy       -19       -20       -22         33       DDRII+       B4       x18       R1Q C A72 36 ABv-yy       -19       -20       -22         34       R1Q F A72 36 ABv-yy       -19       -20       -22       -22         35       QDRII+       B4       x18       R1Q G A72 36 ABv-yy       -19       -20       -22         36       R1Q G A72 18 ABv-yy			<b>B</b> 2			x18	R1Q 6 A72 18 A B	v- yy							-20	22	_10		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	15	SIO	DZ			x36	R1Q 6 A72 36 A B	v-yy							-30	-33	-40		
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$\begin{array}{c c c c c c c c c c c c c c c c c c c $	18	QURIIT	D4			x36	R1Q A A72 36 A B	v- yy	-19	-20	-22								
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$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	23	DURIT	D4			x18	R1Q C A72 18 A B	v- yy	10	20	22								
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	24		D4			x36	R1Q C A72 36 A B	v- yy	-19	-20	-22								
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			D4			x18	R1Q D A72 18 A B	v- yy	10	20	22								
30       DDRII+       B2       Ni       V       x36       R1Q E A72 36 A Bv- yy       -19       -20       -22         33       33       A       A       R1Q F A72 18 A Bv- yy       -19       -20       -22         35       QDRII+       B4       B4       X36       R1Q F A72 36 A Bv- yy       -19       -20       -22         35       QDRII+       B4       X36       R1Q G A72 36 A Bv- yy       -19       -20       -22         36       QDRII+       B4       X18       R1Q G A72 36 A Bv- yy       -19       -20       -25         38       X36       R1Q H A72 18 A Bv- yy       X36       R1Q J A72 36 A Bv- yy       -25         36       R1Q J A72 36 A Bv- yy       X36       R1Q J A72 36 A Bv- yy       -25         44       QDRII+       B4       X18       R1Q K A72 36 A Bv- yy       -25         44       QDRII+       B4       X18       R1Q K A72 36 A Bv- yy       -25         47       B2       N       X18       R1Q L A72 36 A Bv- yy       -25         47       B2       N       X36       R1Q L A72 36 A Bv- yy       -25         47       B2       N       X36       R1Q L A72 36 A Bv- yy	27	QURIIT	D4			x36	R1Q D A72 36 A B	v- yy	-19	-20	-22								
32 33       32 33       32 33       32 33       33 34       34 34       34 35       34 36       R1Q F A72 18 A Bv- yy x36       -19 R1Q F A72 36 A Bv- yy x36       -22       -22         35 36       QDRII+ 36       84 39       2 36       x18       R1Q G A72 36 A Bv- yy x36       -19 R1Q G A72 36 A Bv- yy x36       -25         38 39 41       82 41       2 84       x18       R1Q H A72 36 A Bv- yy x36       -25       -25         44 42       QDRII+ 45       84       x18       R1Q K A72 36 A Bv- yy x36       -25       -25         44 45       QDRII+ 45       84       x18       R1Q K A72 36 A Bv- yy x36       -25       -25         47 48       82       36 N       x18       R1Q L A72 36 A Bv- yy x36       -25       -25         47 48       82       36 N       x18       R1Q L A72 36 A Bv- yy x36       -25       -25	29		<b>B</b> 2	5	Se	x18	R1Q E A72 18 A B	v- yy	_10	-20	-22								
32 33       B4       B4       18       R1Q F A72 18 A Bv- yy x36       -19       -20       -22         35 36       QDRII+ 36       B4       2       x18       R1Q G A72 18 A Bv- yy x36       r1Q G A72 18 A Bv- yy x36       -25       -25         38 39       DDRII+ 41       B4       2       x18       R1Q H A72 18 A Bv- yy x36       r1Q H A72 36 A Bv- yy x36       -25       -25         41       B4       2       x18       R1Q J A72 18 A Bv- yy x36       r1Q J A72 36 A Bv- yy x36       -25       -25         44       QDRII+ 45       B4       x18       R1Q K A72 18 A Bv- yy x36       -25       -25         44       45       QDRII+ 45       B4       x18       R1Q K A72 36 A Bv- yy x36       -25         47       B2       0       2       x18       R1Q L A72 36 A Bv- yy x36       -25         47       B2       0       2       x18       R1Q L A72 36 A Bv- yy x36       -25         48       DDRII+       B4       36       x18       R1Q L A72 36 A Bv- yy x36       -25         47       x36       R1Q L A72 36 A Bv- yy x36       -25       -25		דוופטט	DZ	5	¥				-13	-20	-22								
33       x36       R1Q F A72 36 ABv- yy       x36       x36       R1Q G A72 36 ABv- yy         35       36       QDRII+       B4       x36       R1Q G A72 36 ABv- yy       -25         38       39       DDRII+       B4       x36       R1Q H A72 36 ABv- yy       -25         41       B4       x36       R1Q J A72 36 ABv- yy       -25         42       B4       x36       R1Q J A72 36 ABv- yy       -25         44       QDRII+       B4       x36       R1Q J A72 36 ABv- yy       -25         44       45       QDRII+       B4       x18       R1Q K A72 18 A Bv- yy       -25         47       48       B2       %       x18       R1Q L A72 36 A Bv- yy       -25         47       48       DDRHL       B2       %       x18       R1Q L A72 36 A Bv- yy       -25         x36       R1Q L A72 36 A Bv- yy       x36       R1Q L A72 36 A Bv- yy       -25		DUNIT	R4			x18	R1Q F A72 18 A B	v- yy	_10	-20									
36       QDRII+       B4       -25         38       39       DDRII+       B2       N       2       X36       R1Q G A72 36 A Bv- yy       -25         41       B4       N       X36       R1Q H A72 18 A Bv- yy       -25       -25         41       B4       X36       R1Q J A72 18 A Bv- yy       -25       -25         44       QDRII+       B4       X36       R1Q J A72 36 A Bv- yy       -25         44       QDRII+       B4       X36       R1Q K A72 18 A Bv- yy       -25         44       QDRII+       B4       X36       R1Q K A72 36 A Bv- yy       -25         47       B2       N       X18       R1Q L A72 36 A Bv- yy       -25         47       B2       N       X18       R1Q L A72 36 A Bv- yy       -25         48       DDRH       B2       N       X18       R1Q L A72 36 A Bv- yy       -25         48       DDRH       B2       N       X18       R1Q L A72 36 A Bv- yy       -25	33		D4			x36	R1Q F A72 36 A B	v- yy	-13	-20	-22								
36       36       36       37       38       39       38       39       38       39       2       x36       R1Q GA72 36 ABV- yy       -25       -25         41       42       84       2       x36       R1Q J A72 36 ABV- yy       -25       -25         44       45       QDRII+       84       x36       R1Q L A72 36 ABV- yy       -25       -25         47       48       B2       9       x18       R1Q L A72 36 ABV- yy       -25       -25         47       48       DDRII+       B2       9       x18       R1Q L A72 36 ABV- yy       -25         47       48       DDRII+       B2       9       x18       R1Q L A72 36 ABV- yy       -25         47       x36       R1Q L A72 36 ABV- yy       -25       -25			D4			x18	R1Q G A72 18 A B	v- yy				25							
39 41 42       DDRII+ 42       D       N       Z       x36       R1Q H A72 36 A Bv- yy x18       -25         44 45       QDRII+ 45       B4       X18       R1Q J A72 18 A Bv- yy x36       R1Q J A72 36 A Bv- yy x36       -25         44 45       QDRII+ 45       B4       X18       R1Q K A72 18 A Bv- yy x36       -25         47 48       B2       N       Y       x18       R1Q L A72 18 A Bv- yy x36       -25         47 48       B2       N       Y       x18       R1Q L A72 36 A Bv- yy x36       -25		QURIT	D4			x36	R1Q G A72 36 A B	v-yy				-25							
39 41 42       DRII+ 42       B4       X30 X18 X18 X18 X18 X18 X10 X18 X10 X18 X10 X18 X10 X18 X10 X17 X18 X17 X18 X10 X17 X17 X18 X10 X17 X18 X10 X17 X18 X10 X17 X17 X18 X10 X17 X17 X18 X10 X17 X17 X18 X10 X17 X17 X17 X17 X17 X17 X17 X17 X17 X17			<b>B</b> 2	0	0	x18	R1Q H A72 18 A B	v- yy				-25							
41       B4       x18       R1Q J A72 18 A BV- yy       -25         44       QDRII+       B4       x36       R1Q J A72 36 A BV- yy       -25         44       QDRII+       B4       x36       R1Q J A72 36 A BV- yy       -25         44       QDRII+       B4       x36       R1Q K A72 36 A BV- yy       -25         47       x36       R1Q L A72 36 A BV- yy       -25         48       DDRIH       B2       x36       R1Q L A72 36 A BV- yy			DZ	5	z							-23							
42       x36       R1Q J A72 36 A Bv- yy         44       QDRII+       B4       x36       R1Q K A72 18 A Bv- yy         47       x36       R1Q K A72 36 A Bv- yy       -25         47       x36       R1Q L A72 36 A Bv- yy       -25         48       DDRIH       B2       x36       R1Q L A72 36 A Bv- yy		DURIT	R4									-25							
45       QDRII+       B4       x36       R1Q K A72 36 A Bv- yy       -25         47       B2       N       Y       x18       R1Q L A72 18 A Bv- yy       -25         48       DDBILL       N       Y       x36       R1Q L A72 36 A Bv- yy       -25			D4			x36	R1Q J A72 36 A B	v-yy				-23							
$\begin{array}{c c c c c c c c c c c c c c c c c c c $			B4									-25							
48 DDBILL BZ N > X36 R1Q L A72 36 A BV- yy -25		QUINIT	04									-23							
			<b>B</b> 2	0	es							-25							
			02	2	×	x36	R1Q L A72 36 A B	v-yy				-23							
	50	DUNIT	B4			x18	R1QMA7218AB	v-yy				-25							
51 D4 X36 R1QMA72 36 A Bv- yy -23	51		04									-23							

Notes:

1. "v" represents the package size. If "v" = "G" then size is  $15 \times 17$  mm, and if "v" = "B" then  $13 \times 15$  mm. 2. "yy" represents the speed bin. "R1QAA7236ABG-20" can operate at 500 MHz(max) of frequency, for example.

3. The part which is not listed above is not supported, as of the day when this datasheet was issued, in spite of the existence of the part number or datasheet.



#### **Pin Arrangement**

R1Q3A	7236 (1	Гор) /	R1QA(	G)A723	36 (Mid)	/ R10	אָD(K)A	7236 (B	ottom)		
	1	2	3	4	5	6	7	8	9	10	11
A	/CQ	NC	SA	/W	/BW2	/K	/BW1	/R	SA	NC	CQ
В	Q27	Q18	D18	SA	/BW3	K	/BW0	SA	D17	Q17	Q8
С	D27	Q28	D19	V <sub>ss</sub>	SA	NC	SA	V <sub>SS</sub>	D16	Q7	D8
D	D28	D20	Q19	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>ss</sub>	Q16	D15	D7
E	Q29	D29	Q20	$V_{DDQ}$	V <sub>ss</sub>	$V_{SS}$	V <sub>SS</sub>	$V_{DDQ}$	Q15	D6	Q6
F	Q30	Q21	D21	$V_{DDQ}$	V <sub>DD</sub>	$V_{SS}$	V <sub>DD</sub>	$V_{DDQ}$	D14	Q14	Q5
G	D30	D22	Q22	$V_{DDQ}$	V <sub>DD</sub>	$V_{SS}$	V <sub>DD</sub>	$V_{DDQ}$	Q13	D13	D5
Н	/DOFF	$V_{REF}$	$V_{DDQ}$	$V_{DDQ}$	V <sub>DD</sub>	V <sub>ss</sub>	V <sub>DD</sub>	$V_{DDQ}$	$V_{DDQ}$	$V_{REF}$	ZQ
J	D31	Q31	D23	$V_{DDQ}$	V <sub>DD</sub>	$V_{SS}$	V <sub>DD</sub>	$V_{DDQ}$	D12	Q4	D4
K	Q32	D32	Q23	$V_{DDQ}$	V <sub>DD</sub>	$V_{SS}$	V <sub>DD</sub>	V <sub>DDQ</sub>	Q12	D3	Q3
L	Q33	Q24	D24	$V_{DDQ}$	V <sub>SS</sub>	$V_{SS}$	V <sub>SS</sub>	V <sub>DDQ</sub>	D11	Q11	Q2
М	D33	Q34	D25	V <sub>SS</sub>	V <sub>ss</sub>	$V_{SS}$	V <sub>SS</sub>	V <sub>ss</sub>	D10	Q1	D2
N	D34	D26	Q25	V <sub>SS</sub>	SA	SA	SA	V <sub>ss</sub>	Q10	D9	D1
Р	Q35	D35	Q26	SA	SA	C QVLD QVLD	SA	SA	Q9	D0	Q0
R	TDO	тск	SA	SA	SA	/C NC ODT	SA	SA	SA	TMS	TDI
					(Top	View)	Тор	←R1Q3	A7236		

R1Q3A7236 (Top) / R1QA(G)A7236 (Mid) / R1QD(K)A7236 (Bottom)

Top ←R1Q3A7236 Mid ←R1QA(G)A7236

Bottom ←R1QD(K)A7236

Notes: 1. Address expansion order for future higher density SRAMs:  $10A \rightarrow 2A \rightarrow 7A \rightarrow 5B$ . 2. NC pins can be left floating or connected to 0V ~ V<sub>DDQ</sub>.

RIQSP	1218 (	iop) /	R IQA(	GATZI	8 (MID)			1210 (0	ollom)		
	1	2	3	4	5	6	7	8	9	10	11
А	/CQ	NC	SA	/W	/BW1	/K	NC	/R	SA	SA	CQ
В	NC	Q9	D9	SA	NC	К	/BW0	SA	NC	NC	Q8
С	NC	NC	D10	V <sub>SS</sub>	SA	NC	SA	$V_{SS}$	NC	Q7	D8
D	NC	D11	Q10	V <sub>SS</sub>	V <sub>SS</sub>	$V_{SS}$	$V_{SS}$	$V_{SS}$	NC	NC	D7
E	NC	NC	Q11	V <sub>DDQ</sub>	V <sub>ss</sub>	$V_{SS}$	$V_{SS}$	$V_{DDQ}$	NC	D6	Q6
F	NC	Q12	D12	$V_{DDQ}$	V <sub>DD</sub>	$V_{SS}$	V <sub>DD</sub>	$V_{\text{DDQ}}$	NC	NC	Q5
G	NC	D13	Q13	V <sub>DDQ</sub>	V <sub>DD</sub>	$V_{SS}$	V <sub>DD</sub>	$V_{DDQ}$	NC	NC	D5
Н	/DOFF	$V_{REF}$	V <sub>DDQ</sub>	V <sub>DDQ</sub>	V <sub>DD</sub>	$V_{SS}$	$V_{DD}$	$V_{DDQ}$	$V_{\text{DDQ}}$	$V_{REF}$	ZQ
J	NC	NC	D14	V <sub>DDQ</sub>	V <sub>DD</sub>	$V_{SS}$	$V_{DD}$	$V_{\text{DDQ}}$	NC	Q4	D4
К	NC	NC	Q14	V <sub>DDQ</sub>	V <sub>DD</sub>	$V_{SS}$	$V_{DD}$	$V_{DDQ}$	NC	D3	Q3
L	NC	Q15	D15	V <sub>DDQ</sub>	V <sub>ss</sub>	$V_{SS}$	$V_{SS}$	$V_{DDQ}$	NC	NC	Q2
М	NC	NC	D16	V <sub>SS</sub>	V <sub>ss</sub>	$V_{SS}$	$V_{SS}$	$V_{SS}$	NC	Q1	D2
N	NC	D17	Q16	V <sub>SS</sub>	SA	SA	SA	$V_{SS}$	NC	NC	D1
Р	NC	NC	Q17	SA	SA	C QVLD QVLD	SA	SA	NC	D0	Q0
R	TDO	тск	SA	SA	SA	/C NC ODT	SA	SA	SA	TMS	TDI
					(Ton )	lion					

R1Q3A7218 (Top) / R1QA(G)A7218 (Mid) / R1QD(K)A7218 (Bottom)

Notes: 1. Address expansion order for future higher density SRAMs: 10A  $\rightarrow$  2A  $\rightarrow$  7A  $\rightarrow$  5B.

2. NC pins can be left floating or connected to 0V ~ V\_{DDQ}.



<sup>(</sup>Top View)

#### **Pin Arrangement**

8 /R SA	9 SA	10	11
-	SΔ		
SA	0/1	SA	CQ
0,1	NC	NC	Q4
V <sub>ss</sub>	NC	NC	D4
V <sub>SS</sub>	NC	NC	NC
V <sub>DDQ</sub>	NC	D3	Q3
V <sub>DDQ</sub>	NC	NC	NC
V <sub>DDQ</sub>	NC	NC	NC
V <sub>DDQ</sub>	V <sub>DDQ</sub>	V <sub>REF</sub>	ZQ
V <sub>DDQ</sub>	NC	Q2	D2
V <sub>DDQ</sub>	NC	NC	NC
	NC	NC	Q1
V <sub>ss</sub>	NC	NC	D1
V <sub>SS</sub>	NC	NC	NC
SA	NC	D0	Q0
		TMS	TDI
	$\begin{array}{c c} V_{DDQ} \\ V_{DDQ} \\ V_{DDQ} \\ V_{DDQ} \\ V_{SS} \\ V_{SS} \\ SA \end{array}$	V <sub>DDQ</sub> V <sub>DDQ</sub> V <sub>DDQ</sub> NC       V <sub>DDQ</sub> NC       V <sub>DDQ</sub> NC       V <sub>SS</sub> NC       V <sub>SS</sub> NC	$\begin{array}{ c c c c }\hline V_{DDQ} & V_{DDQ} & V_{REF} \\ \hline V_{DDQ} & NC & Q2 \\ \hline V_{DDQ} & NC & NC \\ \hline V_{DDQ} & NC & NC \\ \hline V_{SS} & NC & NC \\ \hline V_{SS} & NC & NC \\ \hline SA & NC & D0 \\ \hline \end{array}$

(Top View)

Notes: 1. Address expansion order for future higher density SRAMs:  $10A \rightarrow 2A \rightarrow 7A \rightarrow 5B$ .

2. NC pins can be left floating or connected to 0V ~ V\_{DDQ}.



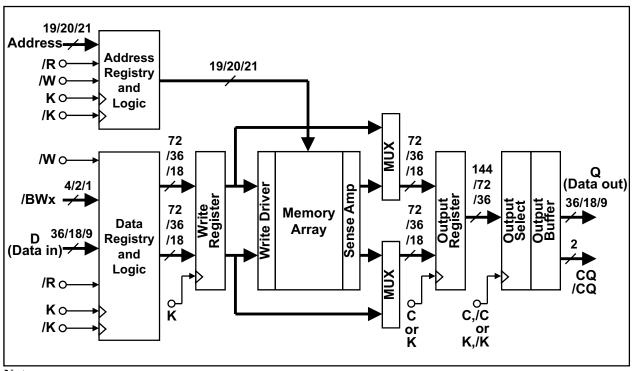
# **Pin Descriptions**

Name	I/O type	Descriptions	Notes
SA	Input	Synchronous address inputs: These inputs are registered and must meet the setup and hold times around the rising edge of K. All transactions operate on a burst-of-four words (two clock periods of bus activity). These inputs are ignored when device is deselected.	
/R	Input	Synchronous read: When low, this input causes the address inputs to be registered and a READ cycle to be initiated. This input must meet setup and hold times around the rising edge of K, and is ignored on the subsequent rising edge of K.	
/W	Input	Synchronous write: When low, this input causes the address inputs to be registered and a WRITE cycle to be initiated. This input must meet setup and hold times around the rising edge of K, and is ignored on the subsequent rising edge of K.	
/BW <sub>x</sub>	Input	Synchronous byte writes: When low, these inputs cause their respective byte to be registered and written during WRITE cycles. These signals are sampled on the same edge as the corresponding data and must meet setup and hold times around the rising edges of K and /K for each of the two rising edges comprising the WRITE cycle. See Byte Write Truth Table for signal to data relationship.	
K, /K	Input	Input clock: This input clock pair registers address and control inputs on the rising edge of K, and registers data on the rising edge of K and the rising edge of /K. /K is ideally 180 degrees out of phase with K. All synchronous inputs must meet setup and hold times around the clock rising edges. These balls cannot remain $V_{\text{REF}}$ level.	
C, /C <b>(II only)</b>	Input	Output clock: This clock pair provides a user-controlled means of tuning device output data. The rising edge of /C is used as the output timing reference for the first and third output data. The rising edge of C is used as the output timing reference for second and fourth output data. Ideally, /C is 180 degrees out of phase with C. C and /C may be tied high to force the use of K and /K as the output reference clocks instead of having to provide C and /C clocks. If tied high, C and /C must remain high and not to be toggled during device operation. These balls cannot remain $V_{\text{REF}}$ level.	1
/DOFF	Input	DLL/PLL disable: When low, this input causes the DLL/PLL to be bypassed for stable, low frequency operation.	
TMS TDI	Input	IEEE1149.1 test inputs: 1.8 V I/O levels. These balls may be left not connected if the JTAG function is not used in the circuit.	
ТСК	Input	IEEE1149.1 clock input: 1.8 V I/O levels. This ball must be tied to $V_{\rm SS}$ if the JTAG function is not used in the circuit.	
R <sup>-</sup> /C	1QE, R1Q pins. In t	3, R1Q4, R1Q5, R1Q6 series have C and /C pins. R1QA, R1QB, R1QC, R F, R1QG, R1QH, R1QJ, R1QK, R1QL, R1QM, R1QN, R1QP series do not he series, K and /K are used as the output reference clocks instead of C an ereafter, C and /C represent K and /K in this document.	have C,



Name	I/O type	Descriptions	Notes
ZQ	Input	Output impedance matching input: This input is used to tune the device outputs to the system data bus impedance. Q and CQ output impedance are set to $0.2 \times RQ$ , where RQ is a resistor from this ball to ground. This ball can be connected directly to $V_{DDQ}$ , which enables the minimum impedance mode. This ball cannot be connected directly to $V_{SS}$ or left unconnected. In ODT (On Die Termination) enable devices, the ODT termination values tracks the value of RQ. The ODT range is selected by ODT control input.	
ODT <b>(il+ only)</b>	Input	<ul> <li>ODT control: When low;</li> <li>[Option 1] Low range mode is selected. The impedance range is between 52 Ω and 105 Ω (Thevenin equivalent), which follows 0.3 × RQ for 175 Ω ≤ RQ ≤ 350 Ω.</li> <li>[Option 2] ODT is disabled.</li> <li>When high; High range mode is selected. The impedance range is between 105 Ω and 150 Ω (Thevenin equivalent), which follows 0.6 × RQ for 175 Ω ≤ RQ ≤ 250 Ω.</li> <li>When floating; [Option 1] High range mode is selected. [Option 2] ODT is disabled.</li> </ul>	1
$D_0$ to $D_n$	Input	Synchronous data inputs: Input data must meet setup and hold times around the rising edges of K and /K during WRITE operations. See Pin Arrangement figures for ball site location of individual signals. The $\times$ 9 device uses D0~D8. D9~D35 should be treated as NC pin. The $\times$ 18 device uses D0~D17. D18~D35 should be treated as NC pin. The $\times$ 36 device uses D0~D35.	
CQ, /CQ	Output	Synchronous echo clock outputs: The edges of these outputs are tightly matched to the synchronous data outputs and can be used as a data valid indication. These signals run freely and do not stop when Q tristates.	
TDO	Output	IEEE 1149.1 test output: 1.8 V I/O level.	
$Q_0$ to $Q_n$	Output	Synchronous data outputs: Output data is synchronized to the respective C and /C, or to the respective K and /K if C and /C are tied high. This bus operates in response to /R commands. See Pin Arrangement figures for ball site location of individual signals. The $\times$ 9 device uses Q0~Q8. Q9~Q35 should be treated as NC pin. The $\times$ 18 device uses Q0~Q17. Q18~Q35 should be treated as NC pin. The $\times$ 36 device uses Q0~Q35.	
QVLD (ll+ only)	Output	Valid output indicator: The Q Valid indicates valid output data. QVLD is edge aligned with CQ and /CQ.	
V <sub>DD</sub>	Supply	Power supply: 1.8 V nominal. See DC Characteristics and Operating Conditions for range.	2
V <sub>DDQ</sub>	Supply	Power supply: Isolated output buffer supply. Nominally 1.5 V. See DC Characteristics and Operating Conditions for range.	2
V <sub>SS</sub>	Supply	Power supply: Ground.	2
V <sub>REF</sub>	_	HSTL input reference voltage: Nominally V <sub>DDQ</sub> /2, but may be adjusted to improve system noise margin. Provides a reference voltage for the HSTL input buffers.	
NC		No connect: These pins can be left floating or connected to 0V ~ $V_{DDQ}$ .	
		tus: Option 1 = Available, Option 2 = Possible. pply and ground balls must be connected for proper operation of the devic	е.





Block Diagram (R1QxA7236 / R1QxA7218 / R1QxA7209, x=3,A,D,G,K)

Notes

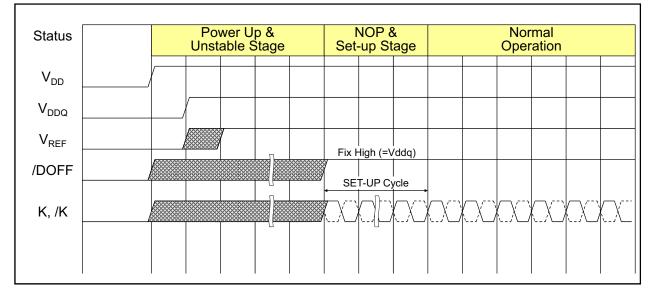
1. C and /C pins do not exist in II+ series parts.



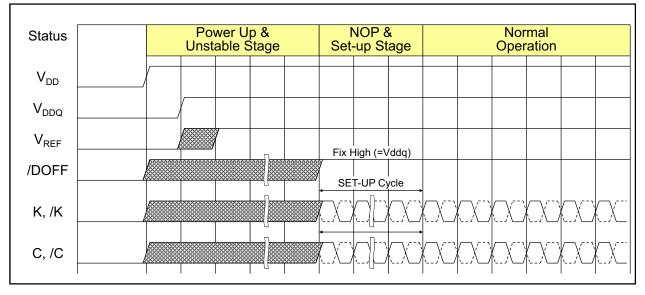
# **General Description**

#### **Power-up and Initialization Sequence**

- $V_{DD}$  must be stable before K, /K clocks are applied.
- Recommended voltage application sequence :  $V_{SS} \rightarrow V_{DD} \rightarrow V_{DDQ} \& V_{REF} \rightarrow V_{IN}$ . (0 V to  $V_{DD}, V_{DDQ} < 200 \text{ ms}$ )
- Apply  $V_{REF}$  after  $V_{DDQ}$  or at the same time as  $V_{DDQ}$ .
- Then execute either one of the following three sequences.
- 1. Single Clock Mode (C and /C tied high)
  - Drive /DOFF high (/DOFF can be tied high from the start).
  - Then provide stable clocks (K, /K) for at least 1024 cycles (II series) or 20 us (II+ series). These meet the QDR common specification of 20 us.
    - When the operating frequency is less than 180 MHz, 2048 cycles are required (II series).



- 2. Double Clock Mode (C and /C control outputs) (II series only)
  - Drive /DOFF high (/DOFF can be tied high from the start)
  - Then provide stable clocks (K, /K, C, /C) for at least 1024 cycles (II series).
     This meets the QDR common specification of 20 us.
     When the operating frequency is less than 180 MHz, 2048 cycles are required (II series).



- 3. DLL/PLL Off Mode (/DOFF tied low)
  - In the "NOP and setup stage", provide stable clocks (K, /K) for at least 1024 cycles (II series) or 20 us (II+ series). These meet the QDR common specification of 20 us.



#### **DLL/PLL Constraints**

- 1. DLL/PLL uses K clock as its synchronizing input. The input should have low phase jitter which is specified as tKC var.
- 2. The lower end of the frequency at which the DLL/PLL can operate is 120 MHz. (Please refer to AC Characteristics table for detail.)
- 3. When the operating frequency is changed or /DOFF level is changed, setup cycles are required again.

#### **Programmable Output Impedance**

1. Output buffer impedance can be programmed by terminating the ZQ ball to  $V_{SS}$  through a precision resistor (RQ). The value of RQ is five times the output impedance desired. The allowable range of RQ to guarantee impedance matching with a tolerance of 15% is 250  $\Omega$  typical. The total external capacitance of ZQ ball must be less than 7.5 pF.



#### **K Truth Table**

Operation	К	/R	/W			D	or Q		
White Origina				Data ir	ı				
Write Cycle: Load address, input write data on two consecutive	↑	H*7	L*8		Input data		D(A+1)	D(A+2)	D(A+3)
K and /K rising edges					nput clock	K(t+1)↑	/K(t+1)↑	K(t+2)↑	/K(t+2)↑
				Data o	ut				
Read Cycle: Load address, output		• *0			utput data	Q(A+0)	Q(A+1)	Q(A+2)	Q(A+3)
read data on two consecutive C and /C	Î	L*8	×	Input	RL*9=1.5	/C(t+1)↑	C(t+2)↑	/C(t+2)↑	C(t+3)↑
rising edges				clock	RL=2.0	C(t+2)↑	/C(t+2)↑	C(t+3)↑	/C(t+3)↑
				for Q	RL=2.5	/C(t+2)↑	C(t+3)↑	/C(t+3)↑	C(t+4)↑
NOP (No operation)	Ť	Н	Н	$D = \times$	or Q = Hi	igh-Z			
Standby (Clock stopped)	Stopped	×	×	× Previous state					

Notes:

- 1. H: high level, L: low level, ×: don't care, ↑: rising edge.
- 2. Data inputs are registered at K and /K rising edges. Data outputs are delivered at C and /C rising edges, except if C and /C are high, then data outputs are delivered at K and /K rising edges.
- 3. /R and /W must meet setup/hold times around the rising edges (low to high) of K and are registered at the rising edge of K.
- 4. This device contains circuitry that will ensure the outputs will be in high-Z during power-up.
- 5. Refer to state diagram and timing diagrams for clarification.
- 6. When clocks are stopped, the following cases are recommended; the case of K = low, /K = high, C = low and /C = high, or the case of K = high, /K = low, C = high and /C = low. This condition is not essential, but permits most rapid restart by overcoming transmission line charging symmetrically.
- 7. If this signal was low to initiate the previous cycle, this signal becomes a "don't care" for this operation; however, it is strongly recommended that this signal be brought high, as shown in the truth table.
- 8. This signal was high on previous K clock rising edge. Initiating consecutive READ or WRITE operations on consecutive K clock rising edges is not permitted. The device will ignore the second request.
- 9. RL = Read Latency (unit = cycle).



### **Byte Write Truth Table** (x 36)

Operation	K	/K	/BW0	/BW1	/BW2	/BW3
Write D0 to D35	1	-	L	L	L	L
	-	1	L	L	L	L
Write D0 to D8	1	-	L	Н	Н	Н
	-	1	L	Н	Н	Н
Write D9 to D17	1	-	Н	L	Н	Н
	-	1	Н	L	Н	Н
Write D18 to D26	1	-	Н	Н	L	Н
	-	1	Н	Н	L	Н
Write D27 to D35	1	-	Н	Н	Н	L
	-	1	Н	Н	Н	L
Write pothing	1	-	Н	Н	Н	Н
Write nothing	-	1	Н	Н	Н	Н

Notes:

1. H: high level, L: low level, ↑: rising edge.

2. Assumes a WRITE cycle was initiated. /BWx can be altered for any portion of the BURST WRITE operation provided that the setup and hold requirements are satisfied.

#### **Byte Write Truth Table** (x 18)

Operation	K	/K	/BW0	/BW1
Write D0 to D17	1	-	L	L
	-	Ť	L	L
Write D0 to D8	1	-	L	Н
	-	Ť	L	Н
Write D9 to D17	1	-	Н	L
	-	Ť	Н	L
Write pothing	1	-	Н	Н
Write nothing	-	Ť	Н	Н

Notes:

1. H: high level, L: low level, ↑: rising edge.

2. Assumes a WRITE cycle was initiated. /BWx can be altered for any portion of the BURST WRITE operation provided that the setup and hold requirements are satisfied.

#### Byte Write Truth Table (x 9) Just Reference except R1Q2A\*\*09 series

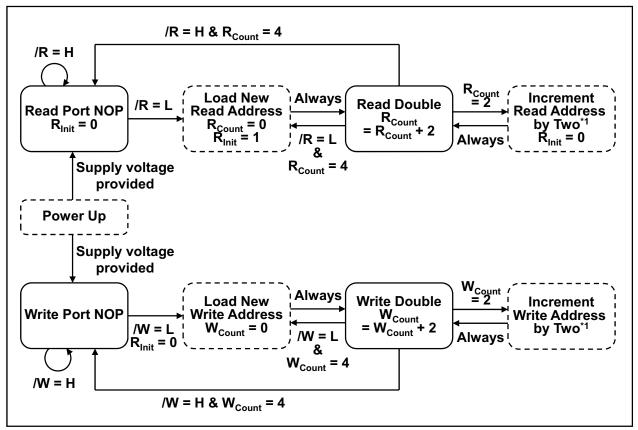
Operation	K	/K	/BW
Write D0 to D8	1	-	L
	-	1	L
Write pothing	1	-	Н
Write nothing	-	↑ (	Н

1. H: high level, L: low level, ↑: rising edge.

2. Assumes a WRITE cycle was initiated. /BWx can be altered for any portion of the BURST WRITE operation provided that the setup and hold requirements are satisfied.



#### **Bus Cycle State Diagram**



Notes:

- The address is concatenated with two additional internal LSBs to facilitate burst operation. The address order is always fixed as: xxx...xxx+0, xxx...xxx+1, xxx...xxx+2, xxx...xxx+3. Bus cycle is terminated at the end of this sequence (burst count = 4).
- 2. Read and write state machines can be active simultaneously. Read and write cannot be simultaneously initiated. Read takes precedence.
- 3. State machine control timing sequence is controlled by K.



#### Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit	Notes
Input voltage on any ball	V <sub>IN</sub>	–0.5 to V <sub>DD</sub> + 0.5 (2.5 V max.)	V	1, 4
Input/output voltage	V <sub>I/O</sub>	–0.5 to V <sub>DDQ</sub> + 0.5 (2.5 V max.)	V	1, 4
Core supply voltage	V <sub>DD</sub>	-0.5 to 2.5	V	1, 4
Output supply voltage	$V_{DDQ}$	-0.5 to V <sub>DD</sub>	V	1, 4
Junction temperature	Tj	+125 (max)	°C	5
Storage temperature	T <sub>STG</sub>	–55 to +125	°C	

Notes:

1. All voltage is referenced to  $V_{SS}$ .

2. Permanent device damage may occur if Absolute Maximum Ratings are exceeded. Functional operation should be restricted the Operation Conditions. Exposure to higher than recommended voltages for extended periods of time could affect device reliability.

- 3. These CMOS memory circuits have been designed to meet the DC and AC specifications shown in the tables after thermal equilibrium has been established.
- The following supply voltage application sequence is recommended: V<sub>SS</sub>, V<sub>DD</sub>, V<sub>DDQ</sub>, V<sub>REF</sub> then V<sub>IN</sub>. Remember, according to the Absolute Maximum Ratings table, V<sub>DDQ</sub> is not to exceed 2.5 V, whatever the instantaneous value of V<sub>DDQ</sub>.
- 5. Some method of cooling or airflow should be considered in the system. (Especially for high frequency or ODT parts)

Parameter	Symbol	Min	Тур	Мах	Unit	Notes
Power supply voltage core	V <sub>DD</sub>	1.7	1.8	1.9	V	1
Power supply voltage I/O	V <sub>DDQ</sub>	1.4	1.5	V <sub>DD</sub>	V	1, 2
Input reference voltage I/O	V <sub>REF</sub>	0.68	0.75	0.95	V	3
Input high voltage	V <sub>IH (DC)</sub>	V <sub>REF</sub> + 0.1		V <sub>DDQ</sub> + 0.3	V	1, 4, 5
Input low voltage	V <sub>IL (DC)</sub>	-0.3	_	V <sub>REF</sub> – 0.1	V	1, 4, 5

# **Recommended DC Operating Conditions**

Notes:

- 1. At power-up,  $V_{DD}$  and  $V_{DDQ}$  are assumed to be a linear ramp from 0V to  $V_{DD}$ (min.) or  $V_{DDQ}$ (min.) within 200ms. During this time  $V_{DDQ} < V_{DD}$  and  $V_{IH} < V_{DDQ}$ . During normal operation,  $V_{DDQ}$  must not exceed  $V_{DD}$ .
- Please pay attention to Tj not to exceed the temperature shown in the absolute maximum ratings table due to current from V<sub>DDQ</sub>.
- 3. Peak to peak AC component superimposed on  $V_{REF}$  may not exceed 5% of  $V_{REF}$ .
- 4. These are DC test criteria. The AC V\_{\rm IH} / V\_{\rm IL} levels are defined separately to measure timing parameters.
- $\begin{array}{ll} \text{5. Overshoot: } V_{\text{IH (AC)}} \leq V_{\text{DDQ}} + 0.5 \text{ V for } t \leq t_{\text{KHKH}}/2 \\ \text{Undershoot: } V_{\text{IL (AC)}} \geq -0.5 \text{ V for } t \leq t_{\text{KHKH}}/2 \\ \text{During normal operation, } V_{\text{IH(DC)}} \text{ must not exceed } V_{\text{DDQ}} \text{ and } V_{\text{IL(DC)}} \text{ must not be lower than } V_{\text{SS}}. \end{array}$

#### **DC Characteristics**

 $(Ta = 0 \sim +70^{\circ}C @ R1Q*A****BB-**R** series, Ta = -40 \sim +85^{\circ}C @ R1Q*A****BB-**I** series) \\ (V_{DD} = 1.8V \pm 0.1V, V_{DDO} = 1.5V, V_{REF} = 0.75V)$ 

#### **Operating Supply Current (Write / Read)**

Symbol =  $I_{DD}$ . Unit = mA. See Notes 1, 2 and 3 in the page after next.

No         Image: Section of the sectin of the section of the section of the section of the se									QI	DR II+	DDR	+		G	DR II	DDR	11
I         Part Number ↓         yy →         -19         -20         -22         -25         -27         -30         -33         -40         -50           1         x         9         P1(2 2 A72 19 A Bv - yy)         x         7         -30         -30         -33         -40         -50           5         B4         x         9         P1(2 2 A72 18 A Bv - yy)         x         x         7         -50         70         670           5         B4         S1         R1Q 2 A72 36 A Bv - yy         x         8         820         730         30         -33         40         -50           11         DDRII         B4         x         R1Q 3 A72 18 A Bv - yy         x         8         820         730         30         -33         40         -50         660         630         90         -30         -33         40         -50         660         630         90         -30         -33         40         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50         -50		e Lot	st th	cy e)	L	-i c	(MHz)	533	500	450	400	375	333	333	300	250	200
1       2       2       1	No	Produ Typ	Burs	Laten (Cycl	DD	Orgai zatio	(ns)	1.875	2.00	2.22	2.50	2.66	3.00	3.00	3.30	4.00	
2       QDRII       B2       3       QDRII       B2       3       R12       247218ABv-yy       800       800       800       780         9       DDRII       B4       9       Si       810       750       700       630         11       DDRII       B4       9       Si       810       750       700       630         12       B4       750       700       630       800 </td <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td>-19</td> <td>-20</td> <td>-22</td> <td>-25</td> <td>-27</td> <td>-30</td> <td>-30</td> <td>-33</td> <td>-40</td> <td>-50</td>								-19	-20	-22	-25	-27	-30	-30	-33	-40	-50
3       QDRII       B4       X36       R1Q 2 A72 36 A Bv-yy       880       820       730         5       0       X36       R1Q 3 A72 16 A Bv-yy       910       880       820       730         9       0       K36       R1Q 3 A72 36 A Bv-yy       910       850       750       700       630         9       0       B4       10       Y       R1Q 4 A72 18 A Bv-yy       810       760       680       700         11       0       B4       10       5 307       700       670       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       700       630       70       700       630       70       700       630       70       700       630       70       700       630       70       700       630       70       70       70       70       70       70       70       70       70 </td <td></td>																	
5       6       84       80       820       730         6       8       90       750       700       630         11			B2														
6       B4       9       36       730       750       750         8       9       DDRII       B4       2       x36       R1Q 4 A72 18 A Bv-yy       810       760       680         11       DDRII       B4       x36       R1Q 5 A72 18 A Bv-yy       810       760       680         14       DDRII       B2       x36       R1Q 5 A72 18 A Bv-yy       750       700       630         15       SIO       B2       x36       R1Q 6 A72 18 A Bv-yy       750       700       630         17       QDRII+       B4       x36       R1Q 6 A72 18 A Bv-yy       750       700       630         18       N16 (A 72 36 A Bv-yy)       1220       1160       1070       810       760       680         20       R1R (Q B A72 36 A Bv-yy)       1220       1160       1070       x36       810       760       680         21       DRI+       B4       K1       K1       R1Q A72 18 A Bv-yy       1220       1160       1070       x36       x36       R1Q C A72 36 A Bv-yy       1280       1220       1130       x36       x36       x36       R1Q C A72 36 A Bv-yy       1280       1200       1130       x36       x		QDRII															830
6       -       -       9       9       9       9       9       9       9       10       850       750         8       9       DDRII       B4       -       -       750       750       630         11       DDRII       B2       -       -       8       R1Q 4 A72 36 AByy       750       700       630         12       DARII       B2       -       -       78       700       700       630         14       DDRII       B2       -       -       -       770       700       630         15       SIO       B2       -       -       -       780       700       630         17       QDRII+       B4       -       -       -       -       750       700       630         17       QDRII+       B4       -       -       -       -       750       700       630       -         18       DDRII+       B4       -       -       -       -       120       1130       -       -       -       -       -       -       -       -       -       -       -       -       -       -			R4														
9       DRI       B2       84       x36       R1Q 4 A72 36 A Bv-yy       810       760       680         11       B4       x36       R1Q 5 A72 18 A Bv-yy       700       670       630         15       SIO       B2       x36       R1Q 6 A72 36 A Bv-yy       700       670       630         17       QDRII+       B4       x36       R1Q 6 A72 36 A Bv-yy       120       1160       107       810       760       680         17       QDRII+       B4       x36       R1Q A A72 36 A Bv-yy       1220       1160       107       810       760       680         21       DRII+       B4       x36       R1Q A A72 36 A Bv-yy       1220       1130			54												850		
9       DRII       B4         11       DDRII       B4         11       B4         12       B4         14       DDRII         15       SIO         16       DDRII         17       GORII+         18       R1Q 6 A72 36 ABv-yy         x36       R1Q A72 36 ABv-yy         x36       R1Q A72 36 ABv-yy         120       DRII+         84       R1Q C A72 36 ABv-yy         110       1060         121       DDRII+         84       R1Q C A72 36 ABv-yy         120       1110         121       DDRII+         84       R1Q C A72 36 ABv-yy       1220       1130         x18       R1Q C A72 36 ABv-yy       1200       130         121       DDRII+       B4       S12       S16       R1Q DA72 36 ABv-yy       1200       1130         122			<b>B</b> 2	1.5	Ň									750	700		
11/12       B4       12       B4       ×18       R1Q 5 A72 18 A By-yy       660       630       590         12       DRII       B2       ×36       R1Q 6 A72 36 A By-yy       700       630         17       QDRII+       B4       ×36       R1Q 6 A72 36 A By-yy       700       630         17       QDRII+       B4       ×36       R1Q A A72 36 A By-yy       1220       1160       1070         20       ×36       R1Q A A72 36 A By-yy       1220       1160       1070       500       680         20       ×36       R1Q A A72 36 A By-yy       1220       1160       1070       50       500 <td></td> <td>וואטט</td> <td>52</td> <td></td> <td>810</td> <td></td> <td></td> <td></td>		וואטט	52											810			
12			R/														
15       SIO       B2       x36       R1Q 6 A72 36 A Bv- yy       810       760       680         17       QDRII+       B4       x36       R1Q 6 A72 36 A Bv- yy       1220       1160       1070         20       The state of the s			54														
15       SIO       ×36       R1Q 6 A72 36 ABV- yy       810       760       680         17       QDRII+       B4       ×36       R1Q AA72 18 ABV- yy       1220       1160       1070         21       DDRII+       B4       %       %       %       810       760       680         221       DDRII+       B4       %	14	DDRII	<b>B</b> 2											750		630	
18       QDRIH       B4       4 </td <td>15</td> <td>SIO</td> <td>DZ</td> <td></td> <td></td> <td>x36</td> <td>R1Q 6 A72 36 A B<mark>v- yy</mark></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td>810</td> <td>760</td> <td>680</td> <td></td>	15	SIO	DZ			x36	R1Q 6 A72 36 A B <mark>v- yy</mark>							810	760	680	
18	17		D4			x18	R1Q A A72 18 A B <mark>v- yy</mark>	1220	1160	1070							
21 23 24       DDRII+ B4       B2 24       \$\$ \$\$ \$\$ \$\$ \$\$ \$\$ \$\$ \$\$ \$\$ \$\$ \$\$ \$\$ \$\$		QURIT	D4			x36	R1Q A A72 36 A B <mark>v- yy</mark>	1280	1220	1130							
23       DDRII+ 24       B4       K1Q B A/2 30 ABV-yy       110       1000       930         24       K18       R1Q C A/2 18 ABV-yy       820       790       750         26       QDRII+ 27       B4       x18       R1Q D A/2 18 ABV-yy       1220       1160       1070         29       X18       R1Q D A/2 18 ABV-yy       1220       1130       x36       R1Q D A/2 18 ABV-yy       1200       130         30       DDRII+ B4       B4       x18       R1Q D A/2 18 ABV-yy       1200       1130       x36       R1Q D A/2 36 ABV-yy       1000       990       920         33       B4       B4       x18       R1Q C A/2 36 ABV-yy       1000       990       920       x36       R1Q C A/2 36 ABV-yy       1000       990       920       x36       R1Q C A/2 36 ABV-yy       820       790       750       750       x36       R1Q C A/2 36 ABV-yy       880       850       800	20		DЭ	5	0	x18	R1Q B A72 18 A B <mark>v- yy</mark>	1030	990	920							
23       B4       R1Q C A72 18 A BV- yy       820       790       750         26       QDRII+       B4       x36       R1Q C A72 36 A BV- yy       880       850       800         27       QDRII+       B4       x18       R1Q D A72 18 A BV- yy       1220       1160       1070         29       30       DRII+       B4       x36       R1Q D A72 18 A BV- yy       1280       120       1130         29       33       B4       x36       R1Q E A72 18 A BV- yy       1280       190       920         33       A18       R1Q E A72 18 A BV- yy       820       790       750       750         33       B4       Priving       Sig       x18       R1Q E A72 36 A BV- yy       1100       900       90         33       A18       R1Q E A72 36 A BV- yy       820       790       750       750         33       A18       R1Q G A72 18 A BV- yy       820       790       750       980         36       QDRII+       B4       Priving       Y       X18       R1Q G A72 36 A BV- yy       980         38       A11       B4       Priving       Y       X36       R1Q G A72 36 A BV- yy       910	21		DZ	5	z	x36	R1Q B A72 36 A B <mark>v- yy</mark>	1110	1060	990							
24       x36       R1Q C A72 36 A Bv-yy       880       850       800         26       QDRII+       B4       x36       R1Q D A72 18 A Bv-yy       1220       1160       1070         29       PARA       B4       x36       R1Q D A72 36 A Bv-yy       1220       1130       990       920         30       DDRII+       B4       x36       R1Q D A72 36 A Bv-yy       1030       990       920         32       DDRII+       B4       x36       R1Q E A72 36 A Bv-yy       1100       1060       990         33       x18       R1Q E A72 36 A Bv-yy       820       790       750       750         33       x36       R1Q G A72 36 A Bv-yy       880       850       800       980         35       QDRII+       B4       x36       R1Q G A72 36 A Bv-yy       880       850       800         38       PARA       B4       x36       R1Q G A72 36 A Bv-yy       980       1060         41       B4       X36       R1Q J A72 36 A Bv-yy       710       710         44       QDRII+       B4       X36       R1Q K A72 18 A Bv-yy       980       1060         44       QDRII+       B4       X36		DURIIT	D4			x18	R1Q C A72 18 A B <mark>v- yy</mark>	820	790	750							
27       QDRII+       B4       y       x36       R1Q D A72 36 A Bv- yy       1280       1220       1130         29       30       DRII+       B2       y       x18       R1Q E A72 36 A Bv- yy       1030       990       920         33       B4       P       x18       R1Q E A72 36 A Bv- yy       1110       1060       990         33       B4       P       x18       R1Q E A72 36 A Bv- yy       820       790       750         33       B4       P       x36       R1Q G A72 36 A Bv- yy       880       850       800         35       QDRII+       B4       X18       R1Q G A72 36 A Bv- yy       880       850       800         36       QDRII+       B4       X18       R1Q G A72 36 A Bv- yy       980       1060         37       X36       R1Q H A72 36 A Bv- yy       980       910       1060         38       B4       X36       R1Q J A72 36 A Bv- yy       910       1060         41       B4       X36       R1Q K A72 36 A Bv- yy       710       760         44       QDRII+       B4       X36       R1Q K A72 36 A Bv- yy       980       1060         45       DDRI+	24		D4			x36	R1Q C A72 36 A B <mark>v- yy</mark>	880	850	800							
27       x36       R1Q D A72 36 A Bv- yy       1280       1220       1130         29       30       DDRII+       B2       vi       vi       x18       R1Q E A72 18 A Bv- yy       1030       990       920         33       B4       vi       vi       x36       R1Q E A72 36 A Bv- yy       1110       1060       990         33       B4       vi       x36       R1Q E A72 36 A Bv- yy       820       790       750         33       x36       R1Q G A72 36 A Bv- yy       820       790       750         36       QDRII+       B4       vi       x36       R1Q G A72 36 A Bv- yy       880       850       800         38       A11       B4       vi       x36       R1Q G A72 36 A Bv- yy       980       1060         38       A11       B4       vi       x36       R1Q J A72 36 A Bv- yy       910       910         41       B4       vi       x36       R1Q J A72 36 A Bv- yy       710       760         42       A11       B4       vi       x36       R1Q K A72 36 A Bv- yy       980       980         44       QDRII+       B4       vi       x36       R1Q K A72 36 A Bv- yy       980			D/					1220	1160	1070							
30       DDRII+       B4       N       N       X36       R1Q E A72 36 A BV- yy       1110       1060       990         33       B4       B4       N       X36       R1Q E A72 36 A BV- yy       820       790       750         33       B4       R1Q F A72 18 A BV- yy       820       790       750         35       QDRII+       B4       X36       R1Q G A72 18 A BV- yy       880       850       800         36       QDRII+       B4       X18       R1Q G A72 18 A BV- yy       980       1060         38       X36       R1Q G A72 36 A BV- yy       980       1060       1060         39       DDRII+       B4       X18       R1Q J A72 18 A BV- yy       910         41       B4       X18       R1Q J A72 36 A BV- yy       710         42       X36       R1Q J A72 36 A BV- yy       760         44       QDRII+       B4       X18       R1Q K A72 36 A BV- yy       980         45       DDRII+       B4       X18       R1Q L A72 36 A BV- yy       980         47       X36       R1Q L A72 36 A BV- yy       910       1060         47       X36       R1Q L A72 36 A BV- yy       910	27	QURIIT	D4			x36	R1Q D A72 36 A B <mark>v- yy</mark>	1280	1220	1130							
32       DDRII+       B4       x18       R1Q F A72 18 A BV- yy       820       790       750         33       33       x36       R1Q F A72 36 A BV- yy       880       850       800         35       QDRII+       B4       x18       R1Q G A72 18 A BV- yy       980         36       QDRII+       B4       x36       R1Q G A72 36 A BV- yy       980         38       x36       R1Q G A72 36 A BV- yy       1060         39       DDRII+       B4       x18       R1Q G A72 36 A BV- yy       910         41       B4       x18       R1Q J A72 36 A BV- yy       910         x36       R1Q J A72 36 A BV- yy       710         x36       R1Q J A72 36 A BV- yy       980         44       QDRII+       B4       x18       R1Q K A72 18 A BV- yy       760         44       QDRII+       B4       x18       R1Q K A72 18 A BV- yy       980         45       DDRII+       B4       x18       R1Q L A72 36 A BV- yy       980         47       x8       x18       R1Q L A72 36 A BV- yy       910         50       DDRII+       B4       x36       R1Q L A72 36 A BV- yy       910         x36       R1Q L A72 36			<b>D</b> 2	5	S			1030	990	920							
32       B4       x18       R1Q F A72 18 A Bv- yy       820       790       750         33       x36       R1Q F A72 36 A Bv- yy       880       850       800         35       QDRII+       B4       x18       R1Q G A72 18 A Bv- yy       880       850       800         36       QDRII+       B4       x36       R1Q G A72 36 A Bv- yy       980       1060         38       x36       R1Q G A72 36 A Bv- yy       980       910       1060         38       x36       R1Q J A72 18 A Bv- yy       910       910       1060         41       B4       x18       R1Q J A72 18 A Bv- yy       710       760         42       x36       R1Q J A72 18 A Bv- yy       760       760         44       QDRII+       B4       x18       R1Q K A72 18 A Bv- yy       980         44       QDRII+       B4       x18       R1Q K A72 36 A Bv- yy       980         45       DDRII+       B4       x18       R1Q L A72 18 A Bv- yy       980         47       x36       R1Q L A72 36 A Bv- yy       980       980         50       X18       R1Q L A72 36 A Bv- yy       910         x36       R1Q L A72 36 A Bv- yy <t< td=""><td></td><td></td><td>DZ</td><td>5</td><td>¥</td><td>x36</td><td>R1Q E A72 36 A B<mark>v</mark>- yy</td><td>1110</td><td>1060</td><td>990</td><td></td><td></td><td></td><td></td><td></td><td></td><td></td></t<>			DZ	5	¥	x36	R1Q E A72 36 A B <mark>v</mark> - yy	1110	1060	990							
33       X36       R1Q F A72 36 A BV- yy       880       850       800         35       QDRII+       B4       X36       R1Q G A72 18 A BV- yy       980         36       Marcoline       X36       R1Q G A72 36 A BV- yy       1060         38       X36       R1Q G A72 36 A BV- yy       850       900         39       Marcoline       B2       X36       R1Q G A72 36 A BV- yy       910         41       B4       X36       R1Q J A72 18 A BV- yy       710         42       X36       R1Q J A72 36 A BV- yy       760         44       QDRII+       B4       X18       R1Q J A72 36 A BV- yy       760         44       QDRII+       B4       X18       R1Q K A72 36 A BV- yy       980         45       QDRII+       B4       X18       R1Q K A72 36 A BV- yy       980         47       X36       R1Q L A72 18 A BV- yy       980       10600         47       X36       R1Q L A72 18 A BV- yy       910       1060         48       DDRII+       B2       X18       R1Q L A72 36 A BV- yy       910         50       X18       R1Q L A72 36 A BV- yy       910       1060         X18       R1Q M A72 18 A BV- yy </td <td>32</td> <td>DURIIT</td> <td>D4</td> <td></td> <td></td> <td>x18</td> <td>R1Q F A72 18 A B<mark>v</mark>- yy</td> <td>820</td> <td>790</td> <td>750</td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td>	32	DURIIT	D4			x18	R1Q F A72 18 A B <mark>v</mark> - yy	820	790	750							
36       QDRII+       B4       84       82       83       81       82       83       81       81       81       81       81       81       81       81       81       81       81       81       81       81       910       9	33		D4			x36	R1Q F A72 36 A B <mark>v- yy</mark>	880	850	800							
36       36       37       36       38       39       39       39       39       39       39       30       36       82       36       R1Q GA72 36 A BV- yy       850         39       39       39       36       81       910       910         41       42       84       36       R1Q J A72 36 A BV- yy       910         42       710       760       760         44       45       84       710       760         45       84       710       760       760         47       82       71       81       81Q K A72 36 A BV- yy       980         47       82       71       81       81Q K A72 36 A BV- yy       980         47       82       71       81       81Q L A72 36 A BV- yy       980         47       82       71       81       81Q L A72 36 A BV- yy       910         50       71       710       850       710       710	35		D4			x18	R1Q G A72 18 A B <mark>v- yy</mark>				980						
39 41 42       DRII+ 42       B4       B2       N       Ž       x36       R1Q H A72 36 A BV- yy       910         42       B4       B4       X18       R1Q J A72 18 A BV- yy       710         44 45       QDRII+ 45       B4       X18       R1Q J A72 36 A BV- yy       760         44 45       QDRII+ 45       B4       X18       R1Q K A72 18 A BV- yy       980         47       X36       R1Q L A72 36 A BV- yy       1060         48       DDRII+ 50       B2       N       y       x18       R1Q L A72 36 A BV- yy       850         x36       R1Q L A72 36 A BV- yy       910       x18       R1Q L A72 36 A BV- yy       910         50       N       X18       R1Q M A72 18 A BV- yy       910       x18	36	QURIIT	D4			x36	R1Q G A72 36 A Bv- yy				1060						
33       DDRII+ 41       B4       X30       R1Q I A72 36 A BV-yy       510         44       B4       X36       R1Q J A72 36 A BV-yy       710         44       QDRII+ 45       B4       X18       R1Q J A72 36 A BV-yy       760         44       QDRII+ 45       B4       X18       R1Q K A72 18 A BV-yy       980         47       X36       R1Q L A72 36 A BV-yy       1060         47       X36       R1Q L A72 18 A BV-yy       850         48       DDRII+       B4       X36       R1Q L A72 36 A BV-yy       910         50       X18       R1Q L A72 18 A BV-yy       710       910	38		<b>D</b> 2	0	0	x18	R1Q H A72 18 A Bv- yy				850						
41       B4       ×18       R1Q J A72 18 A Bv-yy       710         42       760       760         44       QDRII+       B4       ×18       R1Q J A72 36 A Bv-yy       760         44       QDRII+       B4       ×18       R1Q K A72 18 A Bv-yy       980         45       DDRII+       B4       ×18       R1Q K A72 36 A Bv-yy       1060         47       82       %       ×18       R1Q L A72 36 A Bv-yy       910         50       DDRII+       B4       ×18       R1Q M A72 18 A Bv-yy       910         50       R1       R1Q M A72 18 A Bv-yy       710       710	39		B2	5	Ž	x36	R1Q H A72 36 A Bv- yy				910						
42       43       A       X36       R1Q J A72 36 A BV- yy       760         44       QDRII+       B4       X18       R1Q K A72 18 A BV- yy       980         45       X36       R1Q K A72 36 A BV- yy       1060         47       X36       R1Q L A72 18 A BV- yy       850         48       X36       R1Q L A72 36 A BV- yy       910         50       X18       R1Q L A72 18 A BV- yy       710	41	DDRII+	<b>D</b> 4			x18	R1Q J A72 18 A Bv- yy				710						
44 45 45 47 48 50       A       B4 50       B4 50       B4 50       B4 50       S	42	,	В4			x36	R1Q J A72 36 A Bv- yy				760						
45       QDRIF       B4         47       82       N       9       X36       R1Q K A72 36 A Bv- yy       1060         47       82       N       X18       R1Q L A72 18 A Bv- yy       850         50       P4       P4       P4       P4       P4         50       P4       P4       P4       P4         70       P4       P4       P4       P4         70       P4       P4       P4       P4	_		D4								980						
47         B2         %         x18         R1Q L A72 18 A Bv- yy         850           48         DDRII+         B2         %         x36         R1Q L A72 36 A Bv- yy         910           50         P4         R1         R1Q L A72 18 A Bv- yy         910           50         R1         R1Q M A72 18 A Bv- yy         710		QDRII+	В4			x36	R1Q K A72 36 A Bv- yy				1060						
48         DDRII+         B2         N         ×         x36         R1Q L A72 36 A Bv- yy         910           50         B4         R1         R1Q L A72 36 A Bv- yy         910			DO	0	S												
50 DDRIT R18 R1QMA72 18 A Bv- yy 710			62	5	¥						910						
51 D <sup>4</sup> x 36 R1QM A72 36 A By- yy 760		DURII+	D4								710						
			В4			x36	R1Q M A72 36 A Bv- yy										

Notes:

1. "v" represents the package size. If "v" = "G" then size is 15 x 17 mm, and if "v" = "B" then 13 x 15 mm.

2. "yy" represents the speed bin. "R1QAA7236ABG-20" can operate at 500 MHz(max) of frequency, for example.



#### Standby Supply Current (NOP)

Symbol =  $I_{SB1}$ . Unit = mA. See Notes 2, 4 and 5 in the next page.

								Q	DR II+	/ DDR	+		6	DR II	DDR	II
						Frequency (max)										
	t .	<u>م</u> ب	2 3		ے <u>ن</u>	(MHz)	533	500	450	400	375	333	333	300	250	200
No	Product Type	Burst -ength	_atency (Cycle)	ODT	Organi- zation	Cycle Time (min)									4.00	
	Prc T	Burst Length	Latency (Cycle)	0	Organi- zation	(ns)	1.875	2.00	2.22	2.50	2.66	3.00	3.00	3.30	4.00	5.00
			-			Part Number 🗼 yy 🛏	-19	-20	-22	-25	-27	-30	-30	-33	-40	-50
1					x 9	R1Q 2 A72 09 A Bv- yy									570	510
2		B2			x18	R1Q 2 A72 18 A Bv- yy									670	600
3	QDRII				x36	R1Q 2 A72 36 A Bv- yy									710	630
5		B4			x18	R1Q 3 A72 18 A Bv- yy							630	590	520	
6		D4			x36	R1Q 3 A72 36 A Bv- yy							650	610	540	
8		B2	1.5	۶	x18	R1Q 4 A72 18 A Bv- yy							650	610	560	
9	DDRII	DZ			x36	R1Q 4 A72 36 A Bv- yy							710	670	610	
11	DURII	B4			x18	R1Q 5 A72 18 A Bv- yy							540	510	480	
12		D4			x36	R1Q 5 A72 36 A Bv- yy							570	540	500	
14	DDRII	B2			x18	R1Q 6 A72 18 A Bv- yy							650	610	560	
15	SIO	DZ			x36	R1Q 6 A72 36 A Bv- yy							710	670	610	
17	QDRII+	B4			x18	R1Q A A72 18 A Bv- yy	870	830	780							
18	QURIIT	D4			x36	R1Q A A72 36 A Bv- yy	910	870	810							
20		B2	2.5	٩N	x18	R1Q B A72 18 A Bv- yy	870	840	780							
21	DDRII+	DZ	2	z	x36	R1Q B A72 36 A Bv- yy	960	920	860							
23	DURIIT	B4			x18	R1Q C A72 18 A B <mark>v- yy</mark>	690	660	630							
24		D4				R1Q C A72 36 A Bv- yy	730	710	670							
26	QDRII+	B4				R1Q D A72 18 A B <mark>v- yy</mark>	870	830	780							
27	QUINIT	54				R1Q D A72 36 A Bv- yy	910	870	810							
29		B2	2.5	Yes		R1Q E A72 18 A B <mark>v- yy</mark>	870	840	780							
30	DDRII+	DZ	2	×		R1Q E A72 36 A B <mark>v- yy</mark>	960	920	860							
32		B4				R1Q F A72 18 A B <mark>v- yy</mark>	690	660	630							
33		54				R1Q F A72 36 A B <mark>v- yy</mark>	730	710	670							
35	QDRII+	B4				R1Q G A72 18 A Bv- yy				720						
36	QUIT	54				R1Q G A72 36 A Bv- yy				770						
38		B2	2.0	٩N	x18	R1Q H A72 18 A Bv- yy				720						
39	DDRII+	DZ	2	z		R1Q H A72 36 A Bv- yy				790						
41	DUINIT	B4				R1Q J A72 18 A B <mark>v- yy</mark>				590						
42		D4				R1Q J A72 36 A Bv- yy				630						
44	QDRII+	B4				R1Q K A72 18 A B <mark>v- yy</mark>				720						
45						R1Q K A72 36 A B <mark>v- yy</mark>				770						
47		B2	2.0	Yes		R1Q L A72 18 A B <mark>v- yy</mark>				720						
48	DDRII+	02	2	×		R1Q L A72 36 A B <mark>v- yy</mark>				790						
50	CONIT	B4				R1Q M A72 18 A B <mark>v- yy</mark>				590						
51		04			x36	R1Q M A72 36 A B <mark>v- yy</mark>				630						

Notes:

1. "v" represents the package size. If "v" = "G" then size is  $15 \times 17$  mm, and if "v" = "B" then  $13 \times 15$  mm.

2. "yy" represents the speed bin. "R1QAA7236ABG-20" can operate at 500 MHz(max) of frequency, for example.



Parameter	Symbol	Min	Max	Unit	Test condition	Notes
Input leakage current	ILI	-2	2	μA		10
Output leakage current	I <sub>LO</sub>	-5	5	μA		11
Output high voltage	V <sub>OH</sub> (Low)	$V_{DDQ}^{} - 0.2$	V <sub>DDQ</sub>	V	I <sub>OH</sub>   ≤ 0.1 mA	8, 9
	V <sub>OH</sub>	V <sub>DDQ</sub> /2 - 0.12	V <sub>DDQ</sub> /2 + 0.12	V	Note 6	8, 9
Output low voltage	V <sub>OL</sub> (Low)	V <sub>SS</sub>	0.2	V	I <sub>OL</sub> ≤ 0.1 mA	8, 9
	V <sub>OL</sub>	V <sub>DDQ</sub> /2 - 0.12	V <sub>DDQ</sub> /2 + 0.12	V	Note 7	8, 9

#### Leakage Currents & Output Voltage

Notes:

1. All inputs (except ZQ,  $V_{REF}$ ) are held at either  $V_{IH}$  or  $V_{IL}$ .

2.  $I_{OUT} = 0$  mA.  $V_{DD} = V_{DD}$  max,  $t_{KHKH} = t_{KHKH}$  min.

3. Operating supply currents ( $I_{DD}$ ) are measured at 100% bus utilization.  $I_{DD}$  of QDR family is current of device with 100% write and 100% read cycle.  $I_{DD}$  of DDR family is current of device with 100% write cycle (if  $I_{DD}$ (Write) >  $I_{DD}$ (Read)) or 100% read cycle (if  $I_{DD}$ (Write) <  $I_{DD}$ (Read)).

4. All address / data inputs are static at either V\_{IN} > V\_{IH} or V\_{IN} < V\_{IL}.

5. Reference value. (Condition = NOP currents are valid when entering NOP after all pending READ and WRITE cycles are completed. )

- 6. Outputs are impedance-controlled.  $|I_{OH}| = (V_{DDQ}/2)/(RQ/5)$  for values of 175  $\Omega \le RQ \le 350 \Omega$ .
- 7. Outputs are impedance-controlled.  $I_{OL} = (V_{DDQ}/2)/(RQ/5)$  for values of 175  $\Omega \le RQ \le 350 \Omega$ .
- 8. AC load current is higher than the shown DC values. AC I/O curves are available upon request.

9. HSTL outputs meet JEDEC HSTL Class I and Class II standards.

10.  $0 \le V_{IN} \le V_{DDQ}$  for all input balls (except V<sub>REF</sub>, ZQ, TCK, TMS, TDI ball).

If R1QD, R1QE, R1QF, R1QK, R1QL, R1QM, R1QP series, balls with ODT do not follow this spec. 11.  $0 \le V_{OUT} \le V_{DDQ}$  (except TDO ball), output disabled.



#### **Thermal Resistance**

Parameter	Symbol	Airflow	Тур	Unit	Test condition	Notes
Junction to Ambient	θ <sub>JA</sub>	1 m/s	11.0	0000		1
Junction to Case	θ <sub>JC</sub>	-	4.4	°C/W	EIA/JEDEC JESD51	
Notes:	-					
1. These parame	eters are o	calculated	l under th	e condi	tion. These are reference values.	
2. Τj = Ta + θ <sub>JA</sub> ×	Pd					
Tj = Tc + θ <sub>JC</sub> ×	Pd					
where						
Tj : juncti	on tempe	rature wh	en the de	vice ha	s achieved a steady-state	
after	applicatio	n of Pd (°	C)			
Ta : ambie	ent tempe	rature (°C	C)			
Tc: temp	erature of	external	surface o	f the pa	ckage or case (°C)	
θ <sub>JA</sub> : therm	nal resista	nce from	junction-t	o-ambie	ent (°C/W)	
θ <sub>JC</sub> : therm	nal resista	nce from	junction-t	o-case	(package) (°C/W)	
Pd : powe	r dissipati	on that p	roduced o	hange	n junction temperature (W) (cf.JES	D51-2A)

#### Capacitance

 $(Ta = +25^{\circ}C, Frequency = 1.0MHz, V_{DD} = 1.8V, V_{DDQ} = 1.5V)$ 

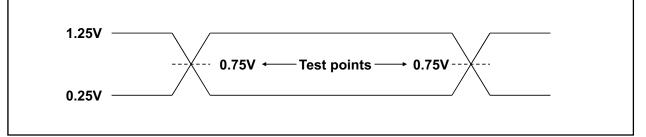
Parameter	Symbol	Min	Тур	Max	Unit	Test condition	Notes
Input capacitance (SA, /R, /W, /BW, D(separate))	C <sub>IN</sub>		4	5	рF	V <sub>IN</sub> = 0 V	1, 2
Clock input capacitance (K, /K, C, /C)	C <sub>CLK</sub>	_	4	5	pF	V <sub>CLK</sub> = 0 V	1, 2
Output capacitance (Q(separate), DQ(common), CQ, /CQ)	C <sub>I/O</sub>	_	5	6	pF	V <sub>I/O</sub> = 0 V	1, 2
Notes:							

1. These parameters are sampled and not 100% tested.

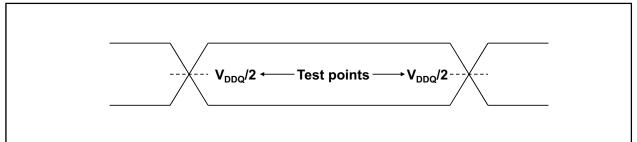
2. Except JTAG (TCK, TMS, TDI, TDO) pins.

#### **AC Test Conditions**

Input waveform (Rise/fall time  $\leq 0.3$  ns)

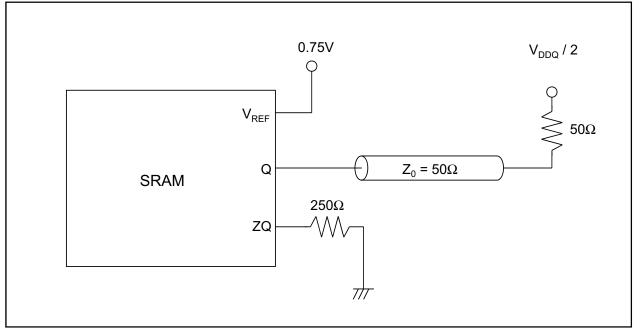


Output waveform





#### **Output load conditions**



# **AC Operating Conditions**

Parameter	Symbol	Min	Тур	Max	Unit	Notes						
Input high voltage	V <sub>IH (AC)</sub>	V <sub>REF</sub> + 0.2			V	1, 2, 3, 4						
Input low voltage	age V <sub>IL (AC)</sub> — V <sub>REF</sub> - 0.2 V 1, 2, 3, 4											
Notes:												
1. All voltages referen	ced to V <sub>SS</sub> (G	ND).										
During normal oper	During normal operation, $V_{DDQ}$ must not exceed $V_{DD}$ .											
2. These conditions ar	2. These conditions are for AC functions only, not for AC parameter test.											
3. Overshoot: V <sub>IH (AC)</sub>	$\leq V_{DDQ} + 0.5$	V for $t \le t_{KHKH}/2$										
Undershoot: V <sub>IL (AC</sub>	$_{0} \ge -0.5 \text{ V for}$	t ≤ t <sub>ĸнкн</sub> /2										
Control input signal	-	ve pulse widths	less than t <sub>r</sub>	<sub>кнкL</sub> (min) or op	erate at	t cycle rates						
less than t <sub>кнкн</sub> (min	).											
4. To maintain a valid	level, the trar	sitioning edge o	of the input	must:								
a. Sustain a const	ant slew rate	from the curren	t AC level t	hrough the targ	et AC le	evel,						
V <sub>IL (AC)</sub> or V <sub>IH (AC)</sub> .												
b. Reach at least t	/	level.										
c. After the AC target level is reached, continue to maintain at least the target DC level,												

 $V_{IL (DC)}$  or  $V_{IH (DC)}$ .



#### AC Characteristics (QDR-II, DDR-II series)

 $\begin{array}{ll} (Ta = & 0 \sim +70 \,^{\circ}\text{C} @ R1Q*A****BB-**R** \text{ series}) \\ (Ta = -40 \sim +85 \,^{\circ}\text{C} @ R1Q*A****BB-**I** \text{ series}) \\ (V_{\text{DD}} = & 1.8V \pm 0.1V, V_{\text{DDQ}} = & 1.5V, V_{\text{REF}} = & 0.75V) \end{array}$ 

Demoster	0	-3	0	-3	3	-4	0	-5	50	_	_	_	_	11	
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Clock															
Average clock cycle time (K, /K, C, /C)	t <sub>кнкн</sub>	3.00	8.40	3.30	8.40	4.00	8.40	5.00	8.40					ns	8
Clock high time (K, /K, C, /C)	t <sub>KHKL</sub>	1.20		1.32	_	1.60		2.00			—		_	ns	
Clock low time (K, /K, C, /C)	t <sub>KLKH</sub>	1.20	_	1.32		1.60	_	2.00			—		_	ns	
Clock to /clock (K to /K, C to /C)	t <sub>KH/KH</sub>	1.35		1.49		1.80		2.20		_				ns	
/Clock to clock (/K to K, /C to C)	t <sub>/KHKH</sub>	1.35		1.49		1.80		2.20						ns	
Clock to data clock (K to C, /K to /C)	t <sub>ĸнсн</sub>	0	1.35	0	1.49	0	1.80	0	2.20					ns	
DLL/PLL Ti	ming														
Clock phase jitter (K, /K, C, /C)	t <sub>ĸc</sub> var		0.20		0.20		0.20		0.20		_			ns	3
Lock time (K, C)	t <sub>KC</sub> lock	1024		1024		1024		1024						Cy- cle	2
K static to DLL/PLL reset	t <sub>KC</sub> reset	30		30		30		30						ns	7
Output Times															
C, /C high to output valid	t <sub>CHQV</sub>		0.45		0.45		0.45		0.45					ns	9
C, /C high to output hold	t <sub>CHQX</sub>	-0.45		-0.45		-0.45		-0.45						ns	9
C, /C high to echo clock valid	t <sub>CHCQV</sub>		0.45		0.45		0.45		0.45	_				ns	9
C, /C high to echo clock hold	t <sub>CHCQX</sub>	-0.45		-0.45		-0.45		-0.45						ns	9
CQ, /CQ high to output valid	t <sub>CQHQV</sub>		0.25		0.27		0.30		0.35		_			ns	4, 7
CQ, /CQ high to output hold	t <sub>CQHQX</sub>	-0.25		-0.27		-0.30		-0.35			_			ns	4, 7
C, /C high to output high-Z	t <sub>chqz</sub>		0.45		0.45		0.45		0.45					ns	5, 6, 9
C, /C high to output low-Z	t <sub>CHQX1</sub>	-0.45		-0.45		-0.45		-0.45			_			ns	5, 9
		—	—							]	—		—	—	



#### R1Q3A7236ABB / R1Q3A7218ABB Series

		-3	30	-3	3	-40		-5	50		_				
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Setup Times									-	-					
Address valid to	t <sub>AVKH</sub> for R1Q2					0.35		0.40				_		ns	1
K rising edge	t <sub>AVKH</sub> for R1Q3/4/5/6	0.40	_	0.40	_	0.50	_	0.60						115	I
Control inputs valid to	t <sub>іVKH</sub> for R1Q2					0.35		0.40						ns	1
K rising edge	t <sub>IVKH</sub> for R1Q3/4/5/6	0.40		0.40		0.50		0.60				_		115	I
Data-in valid to K, /K rising edge	t <sub>ovkh</sub>	0.28		0.30	_	0.35	_	0.40		_				ns	1
Hold Times															
K rising edge	t <sub>KHAX</sub> for R1Q2	—		_	_	0.35	_	0.40				_		20	1
to address hold	t <sub>KHAX</sub> for R1Q3/4/5/6	0.40	_	0.40	_	0.50	_	0.60				_		ns	
K rising edge	t <sub>ĸнıx</sub> for R1Q2	—		_	_	0.35		0.40				_		20	1
to control inputs hold	t <sub>KHIX</sub> for R1Q3/4/5/6	0.40		0.40		0.50		0.60						ns	
K, /K rising edge to data-in hold	t <sub>KHDX</sub>	0.28		0.30		0.35		0.40						ns	1

Notes:

1. This is a synchronous device. All addresses, data and control lines must meet the specified setup and hold times for all latching clock edges.

V<sub>DD</sub> and V<sub>DDQ</sub> slew rate must be less than 0.1 V DC per 50 ns for DLL/PLL lock retention. DLL/PLL lock time begins once V<sub>DD</sub>, V<sub>DDQ</sub> and input clock are stable.

It is recommended that the device is kept inactive during these cycles.

This specification meets the QDR common spec. of 20 us.

- 3. Clock phase jitter is the variance from clock rising edge to the next expected clock rising edge.
- Echo clock is very tightly controlled to data valid / data hold. By design, there is a ±0.1 ns variation from echo clock to data. The datasheet parameters reflect tester guardbands and test setup variations.
- 5. Transitions are measured  $\pm 100 \text{ mV}$  from steady-state voltage.
- 6. At any given voltage and temperature  $t_{CHQZ}$  is less than  $t_{CHQX1}$  and  $t_{CHQV}$ .
- 7. These parameters are sampled.
- When x18 and x36 configuration except QDRII-B2 are operated at less than 180MHz, DLL/PLL should be disabled (/DOFF=L). Please contact Renesas if these devices are always used at less than 180MHz with DLL/PLL operation.
- t<sub>CHQV</sub>, t<sub>CHQX</sub>, t<sub>CHQQV</sub>, t<sub>CHQQX</sub>, t<sub>CHQZ</sub>, t<sub>CHQX1</sub> spec of R1Q3A and R1Q4A series is determined by the actual frequency regardless of Part Number (Marking Name). The following is the spec for the actual frequency. t<sub>CHQV</sub>, t<sub>CHQQV</sub>, t<sub>CHQQV</sub>, t<sub>CHQZ</sub> = 0.45 ns for ≥ 200 MHz and 0.50 ns for < 200 MHz</li>

 $t_{CHQX}$ ,  $t_{CHQX}$ ,  $t_{CHQX}$ ,  $t_{CHQX1}$  = -0.45 ns for  $\ge 200$  MHz and -0.50 ns for < 200 MHz

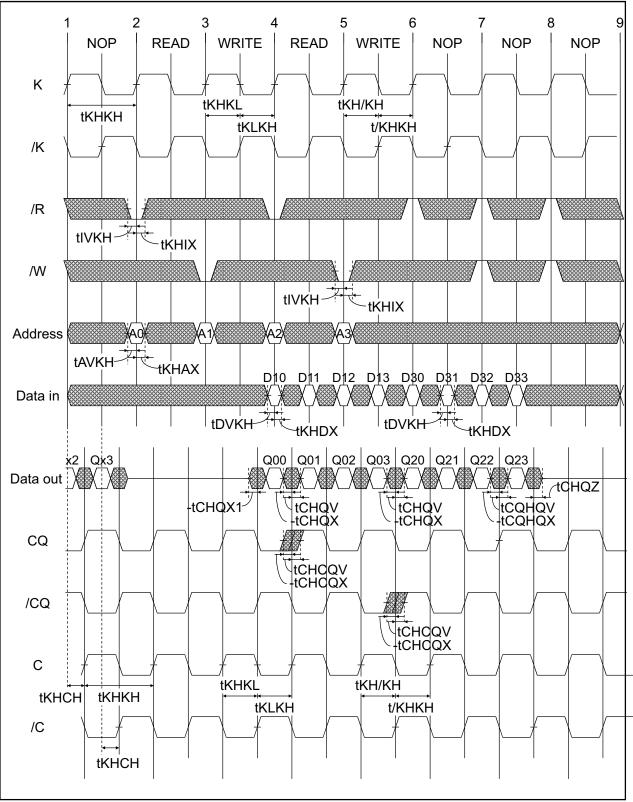
Remarks:

- 1. Test conditions as specified with the output loading as shown in AC Test Conditions unless otherwise noted.
- 2. Control input signals may not be operated with pulse widths less than  $t_{KHKL}$  (min).
- 3. If C, /C are tied high, K, /K become the references for C, /C timing parameters.
- 4.  $V_{DDQ}$  is +1.5 V DC.  $V_{REF}$  is +0.75 V DC.
- 5. Control signals are /R, /W (QDR series), /LD, R-/W (DDR series), /BW, /BW0, /BW1, /BW2 and /BW3. Setup and hold times of /BWx signals must be the same as those of Data-in signals.



#### **Timing Waveforms**

Read and Write Timing (QDRII, B4, Read Latency = 1.5 cycle)



Notes:

- 1. Q00 refers to output from address A0+0. Q01 refers to output from the next internal burst address following A0, i.e., A0+1.
- 2. Outputs are disabled (high-Z) N clock cycle after the last read cycle. Here, N = Read Latency + Burst Length  $\times$  0.5.
- 3. In this example, if address A2 = A1, then data Q20 = D10, Q21 = D11. Write data is forwarded immediately as read results.
- 4. To control read and write operations, /BW signals must operate at the same timing as Data-in signals.



# **JTAG Specification**

These products support a limited set of JTAG functions as in IEEE standard 1149.1.

#### **Disabling the Test Access Port**

It is possible to use this device without utilizing the TAP. To disable the TAP controller without interfering with normal operation of the device, TCK must be tied to  $V_{SS}$  to preclude mid level inputs.

TDI and TMS are internally pulled up and may be unconnected, or may be connected to VDD through a pull up resistor.

TDO should be left unconnected.

#### **Test Access Port (TAP) Pins**

Symbol I/O	Pin assignments	Description	Notes
тск	2R	Test clock input. All inputs are captured on the rising edge of TCK and all outputs propagate from the falling edge of TCK.	
TMS	10R	Test mode select. This is the command input for the TAP controller state machine.	
TDI	11R	Test data input. This is the input side of the serial registers placed between TDI and TDO. The register placed between TDI and TDO is determined by the state of the TAP controller state machine and the instruction that is currently loaded in the TAP instruction.	
TDO	1R	Test data output. Output changes in response to the falling edge of TCK. This is the output side of the serial registers placed between TDI and TDO.	
Notes:			
TMS		e TRST (TAP reset). The Test-Logic Reset state is entered wh rising edges of TCK. The TAP controller state is also reset on	



#### **TAP DC Operating Characteristics**

 $\begin{array}{ll} (Ta = & 0 \sim +70^{\circ}C @ R1Q*A****BB-**R** \ series) \\ (Ta = -40 \sim +85^{\circ}C @ R1Q*A****BB-**I** \ series) \\ (V_{DD} = 1.8V \pm 0.1V) \end{array}$ 

Parameter	Symbol	Min	Тур	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	+1.3	_	V <sub>DD</sub> + 0.3	V	
Input low voltage	V <sub>IL</sub>	-0.3		+0.5	V	
Input leakage current	I <sub>LI</sub>	-5.0		+5.0	μA	$0 V \le V_{IN} \le V_{DD}$
Output leakage current	I <sub>LO</sub>	-5.0		+5.0	μA	$0 V \le V_{IN} \le V_{DD},$ output disabled
Output low voltage	V <sub>OL1</sub>			0.2	V	I <sub>OLC</sub> = 100 μA
Output low voltage	V <sub>OL2</sub>			0.4	V	I <sub>OLT</sub> = 2 mA
Output high voltage	V <sub>OH1</sub>	1.6			V	I <sub>OHC</sub>   = 100 μA
	V <sub>OH2</sub>	1.4			V	I <sub>OHT</sub>   = 2 mA

Notes:

1. All voltages referenced to  $V_{SS}$  (GND).

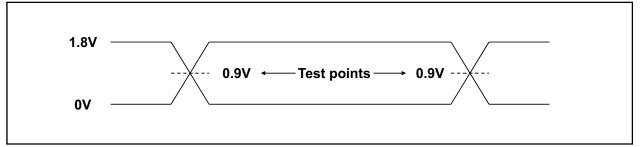
2. At power-up,  $V_{DD}$  and  $V_{DDQ}$  are assumed to be a linear ramp from 0V to  $V_{DD}$  (min.) or  $V_{DDQ}$  (min.) within 200ms. During this time  $V_{DDQ} < V_{DD}$  and  $V_{IH} < V_{DDQ}$ . During normal operation,  $V_{DDQ}$  must not exceed  $V_{DD}$ .



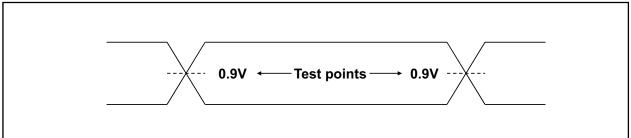
#### **TAP AC Test Conditions**

Parameter	Symbol	Conditions	Unit	Notes
Input timing measurement reference levels	V <sub>REF</sub>	0.9	V	
Input pulse levels	V <sub>IL</sub> , V <sub>IH</sub>	0 to 1.8	V	
Input rise/fall time	tr, tf	≤ 1.0	ns	
Output timing measurement reference levels		0.9	V	
Test load termination supply voltage ( $V_{TT}$ )		0.9	V	
Output load		See figures		

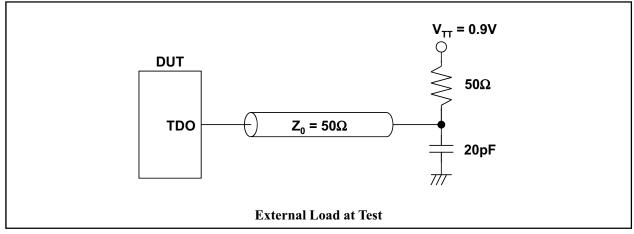
Input waveform



#### **Output waveform**









#### **TAP AC Operating Characteristics**

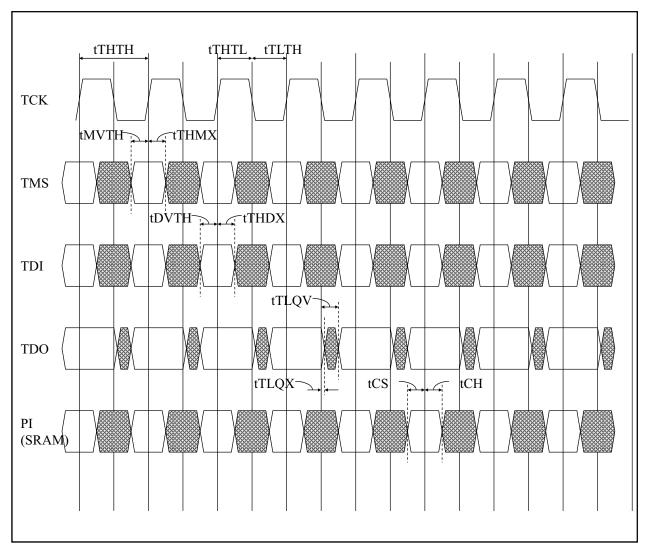
 $\begin{array}{ll} (Ta = & 0 \sim +70^{\circ}C @ R1Q*A****BB-**R** \ series) \\ (Ta = -40 \sim +85^{\circ}C @ R1Q*A****BB-**I** \ series) \\ (V_{DD} = & 1.8V \pm 0.1V) \end{array}$ 

Symbol	Min	Тур	Max	Unit	Notes
t <sub>тнтн</sub>	50			ns	
t <sub>THTL</sub>	20			ns	
t <sub>⊤∟⊤н</sub>	20			ns	
t <sub>MVTH</sub>	5			ns	
t <sub>THMX</sub>	5			ns	
t <sub>cs</sub>	5			ns	1
t <sub>CH</sub>	5			ns	1
t <sub>DVTH</sub>	5			ns	
4	5		_	ns	
	0			ns	
t <sub>TLQV</sub>			10	ns	
	$\begin{array}{c} t_{THTH} \\ t_{THTL} \\ t_{TLTH} \\ t_{MVTH} \\ t_{THMX} \\ t_{CS} \\ t_{CH} \\ t_{DVTH} \\ t_{THDX} \\ t_{TLQX} \\ t_{TLQX}$	t <sub>тнтн</sub> 50           t <sub>тнтL</sub> 20           t <sub>пLTH</sub> 20           t <sub>пLTH</sub> 20           t <sub>MVTH</sub> 5           t <sub>CS</sub> 5           t <sub>CH</sub> 5           t <sub>CH</sub> 5           t <sub>DVTH</sub> 5           t <sub>THDX</sub> 5           t <sub>TLQX</sub> 0	t <sub>тнтн</sub> 50         —           t <sub>тнтL</sub> 20         —           t <sub>TLTH</sub> 20         —           t <sub>TLTH</sub> 20         —           t <sub>TLTH</sub> 5         —           t <sub>CS</sub> 5         —           t <sub>CS</sub> 5         —           t <sub>CH</sub> 5         —           t <sub>DVTH</sub> 5         —           t <sub>DVTH</sub> 5         —           t <sub>THDX</sub> 5         —           t <sub>TLQX</sub> 0         —	t <sub>THTH</sub> 50     —     —       t <sub>THTL</sub> 20     —     —       t <sub>TLTH</sub> 20     —     —       t <sub>TLTH</sub> 20     —     —       t <sub>TLTH</sub> 5     —     —       t <sub>THMX</sub> 5     —     —       t <sub>CS</sub> 5     —     —       t <sub>CH</sub> 5     —     —       t <sub>DVTH</sub> 5     —     —       t <sub>THDX</sub> 5     —     —       t <sub>TLQX</sub> 0     —     —	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

Notes:

1.  $t_{CS}$  +  $t_{CH}$  defines the minimum pause in RAM I/O pad transitions to assure pad data capture.





# **TAP Controller Timing Diagram**

# **Test Access Port Registers**

Register name	Length	Symbol	Notes
Instruction register	3 bits	IR [2:0]	
Bypass register	1 bit	BP	
ID register	32 bits	ID [31:0]	
Boundary scan register	109 bits	BS [109:1]	



#### **TAP Controller Instruction Set**

IR2	IR1	IR0	Instruction	Description	Notes
0	0	0	EXTEST	The EXTEST instruction allows circuitry external to the component package to be tested. Boundary scan register cells at output balls are used to apply test vectors, while those at input balls capture test results. Typically, the first test vector to be applied using the EXTEST instruction will be shifted into the boundary scan register using the PRELOAD instruction. Thus, during the Update-IR state of EXTEST, the output driver is turned on and the PRELOAD data is driven onto the output balls.	1, 2, 3, 5
0	0	1	IDCODE	The IDCODE instruction causes the ID ROM to be loaded into the ID register when the controller is in capture-DR mode and places the ID register between the TDI and TDO balls in shift- DR mode. The IDCODE instruction is the default instruction loaded in at power up and any time the controller is placed in the Test-Logic-Reset state.	
0	1	0	SAMPLE-Z	If the SAMPLE-Z instruction is loaded in the instruction register, all RAM outputs are forced to an inactive drive state (high-Z), moving the TAP controller into the capture-DR state loads the data in the RAMs input into the boundary scan register, and the boundary scan register is connected between TDI and TDO when the TAP controller is moved to the shift-DR state.	3, 4, 5
0	1	1	RESERVED	The RESERVED instructions are not implemented but are reserved for future use. Do not use these instructions.	
1	0	0	SAMPLE (/PRELOAD)	When the SAMPLE instruction is loaded in the instruction register, moving the TAP controller into the capture-DR state loads the data in the RAMs input and I/O buffers into the boundary scan register. Because the RAM clock(s) are independent from the TAP clock (TCK) it is possible for the TAP to attempt to capture the I/O ring contents while the input buffers are in transition (i.e., in a metastable state). Although allowing the TAP to SAMPLE metastable input will not harm the device, repeatable results cannot be expected. Moving the controller to shift-DR state then places the boundary scan register between the TDI and TDO balls.	3, 5
1	0	1	RESERVED		
1	1	0	RESERVED	-	
1	1	1	BYPASS	The BYPASS instruction is loaded in the instruction register when the bypass register is placed between TDI and TDO. This occurs when the TAP controller is moved to the shift-DR state. This allows the board level scan path to be shortened to facilitate testing of other devices in the scan path.	
Not	00.				

#### Notes:

- 1. Data in output register is not guaranteed if EXTEST instruction is loaded.
- 2. After performing EXTEST, power-up conditions are required in order to return part to normal operation.
- 3. RAM input signals must be stabilized for long enough to meet the TAPs input data capture setup plus hold time ( $t_{CS}$  plus  $t_{CH}$ ). The RAMs clock inputs need not be paused for any other TAP operation except capturing the I/O ring contents into the boundary scan register.
- 4. Clock recovery initialization cycles are required after boundary scan.
- 5. For R1QD, R1QE, R1QF, R1QK, R1QL, R1QM, R1QP series, ODT is disabled in EXTEST, SAMPLE-Z or SAMPLE mode.



# **Boundary Scan Order**

D:/ //		Signal names					Signal names			
Bit #	Ball ID	x9	x18	x36	Bit #	Ball ID	x9	x18	x36	
1	6R	6R/C or NC or ODT/C or NC or ODT/C or NC or ODT3610E		D3	D6	D6				
2	6P	C or QVLD	C or QVLD	C or QVLD	37	10D	NC	NC	D15	
3	6N	SA	SA	SA	38	9E	NC	NC	Q15	
4	7P	SA	SA	SA	39	10C	NC	Q7	Q7	
5	7N	SA	SA	SA	40	11D	NC	D7	D7	
6	7R	SA	SA	SA	41	9C	NC	NC	D16	
7	8R	SA	SA	SA	42	9D	NC	NC	Q16	
8	8P	SA	SA	SA	43	11B	Q4	Q8	Q8	
9	9R	SA	SA	SA	44	11C	D4	D8	D8	
10	11P	Q0	Q0	Q0	45	9B	NC	NC	D17	
11	10P	D0	D0	D0	46	10B	NC	NC	Q17	
12	10N	NC	NC	D9	47	11A	CQ	CQ	CQ	
13	9P	NC	NC	Q9	48	10A	SA	SA	NC	
14	10M	NC	Q1	Q1	49	9A	SA	SA	SA	
15	11N	NC	D1	D1	50	8B	SA	SA	SA	
16	9M	NC	NC	D10	51	7C	SA	SA	SA	
17	9N	NC	NC	Q10	52	6C	NC	NC	NC	
18	11L	Q1	Q2	Q2	53	8A	/R	/R	/R	
19	11M	D1	D2	D2	54	7A	NC	NC	/BW1	
20	9L	NC	NC	D11	55	7B	/BW	/BW0	/BW0	
21	10L	NC	NC	Q11	56	6B	К	K	K	
22	11K	NC	Q3	Q3	57	6A	/K	/K	/K	
23	10K	NC	D3	D3	58	5B	NC	NC	/BW3	
24	9J	NC	NC	D12	59	5A	NC	/BW1	/BW2	
25	9K	NC	NC	Q12	60	4A	/W	/W	/W	
26	10J	Q2	Q4	Q4	61	5C	SA	SA	SA	
27	11J	D2	D4	D4	62	4B	SA	SA	SA	
28	11H	ZQ	ZQ	ZQ	63	3A	SA	SA	SA	
29	10G	NC	NC	D13	64	2A	SA	NC	NC	
30	9G	NC	NC	Q13	65	1A	/CQ	/CQ	/CQ	
31	11F	NC	Q5	Q5	66	2B	NC	Q9	Q18	
32	11G	NC	D5	D5	67	3B	NC	D9	D18	
33	9F	NC	NC	D14	68	1C	NC	NC	D27	
34	10F	NC	NC	Q14	69	1B	NC	NC	Q27	
35	11E	Q3	Q6	Q6	70	3D	NC	Q10	Q19	



#### **Boundary Scan Order**

Bit #	Ball ID	S	ignal name	S	D:4 #	Bit # Ball ID Signal nan			S
DIL #		x9	x18	x36	DIL #	Dall ID	x9	x18	x36
71	3C	NC	D10	D19	91	2L	Q7	Q15	Q24
72	1D	NC	NC	D28	92	3L	D7	D15	D24
73	2C	NC	NC	Q28	93	1M	NC	NC	D33
74	3E	Q5	Q11	Q20	94	1L	NC	NC	Q33
75	2D	D5	D11	D20	95	3N	NC	Q16	Q25
76	2E	NC	NC	D29	96	3M	NC	D16	D25
77	1E	NC	NC	Q29	97	1N	NC	NC	D34
78	2F	NC	Q12	Q21	98	2M	NC	NC	Q34
79	3F	NC	D12	D21	99	3P	Q8	Q17	Q26
80	1G	NC	NC	D30	100	2N	D8	D17	D26
81	1F	NC	NC	Q30	101	2P	NC	NC	D35
82	3G	Q6	Q13	Q22	102	1P	NC	NC	Q35
83	2G	D6	D13	D22	103	3R	SA	SA	SA
84	1H	/DOFF	/DOFF	/DOFF	104	4R	SA	SA	SA
85	1J	NC	NC	D31	105	4P	SA	SA	SA
86	2J	NC	NC	Q31	106	5P	SA	SA	SA
87	3K	NC	Q14	Q23	107	5N	SA	SA	SA
88	3J	NC	D14	D23	108	5R	SA	SA	SA
89	2K	NC	NC	D32	109		INTER- NAL	INTER- NAL	INTER- NAL
90	1K	NC	NC	Q32					

Notes:

In boundary scan mode,

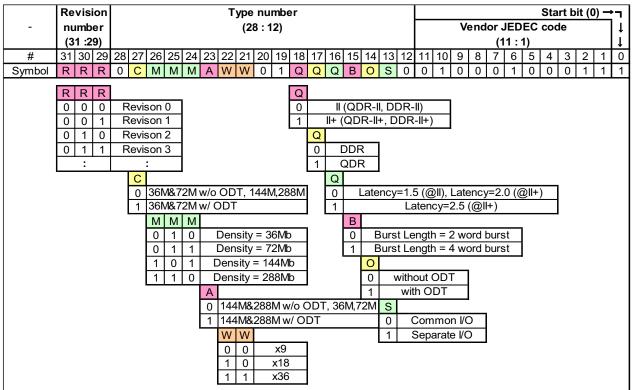
1. Clock balls (K, /K, C, /C) are referenced to each other and must be at opposite logic levels for reliable operation.

2. CQ and /CQ data are synchronized to the respective C and /C (except EXTEST, SAMPLE-Z).

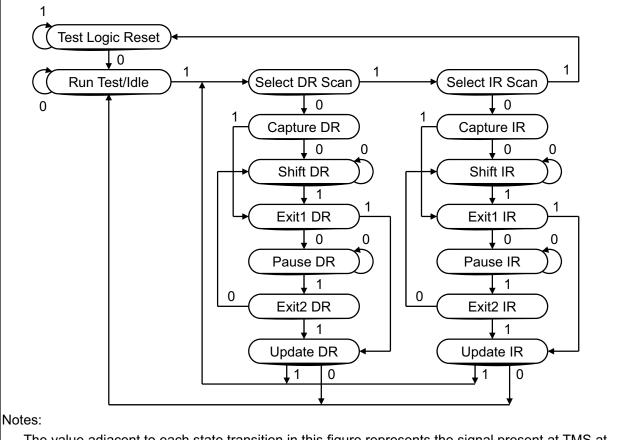
 If C and /C tied high, CQ is generated with respect to K and /CQ is generated with respect to /K (except EXTEST, SAMPLE-Z).



#### **ID Register**



#### **TAP Controller State Diagram**



The value adjacent to each state transition in this figure represents the signal present at TMS at the time of a rising edge at TCK.

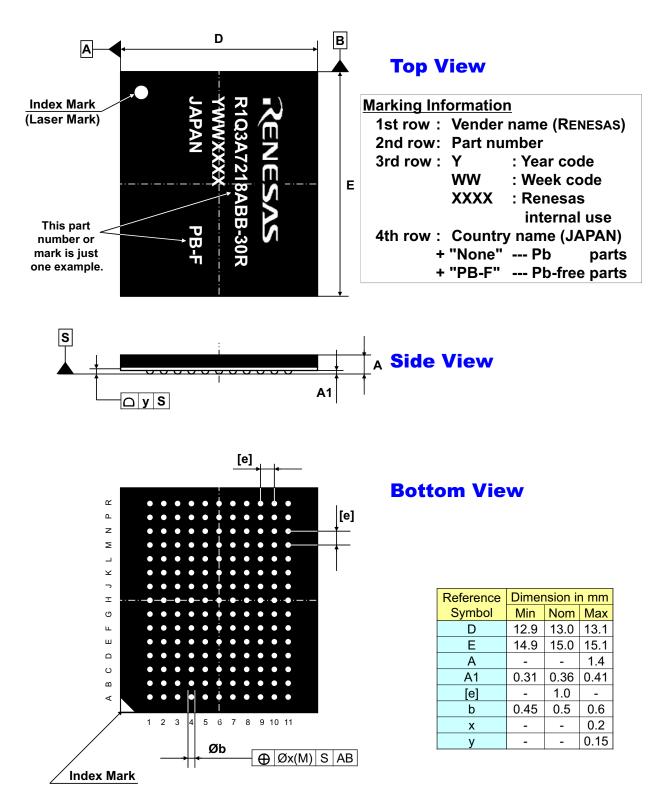
No matter what the original state of the controller, it will enter Test-Logic-Reset when TMS is held high for at least five rising edges of TCK.



# Package Dimensions and Marking Information

Both Pb parts and Pb-free parts are available.

JEITA Package Code	Renesas Code	Previous Code	Mass (typ.)
P-LBGA165-13x15-1.00	PLBG0165FE-A	165FHG	0.5g

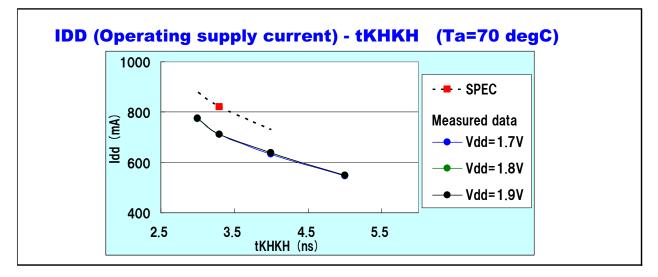


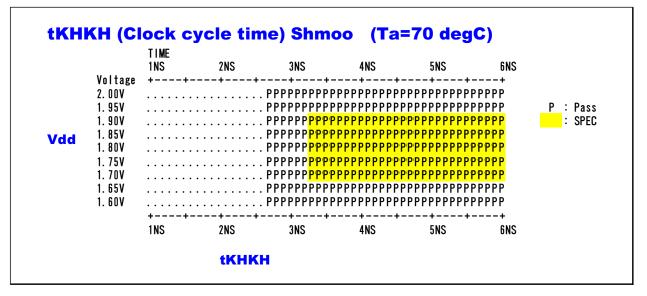


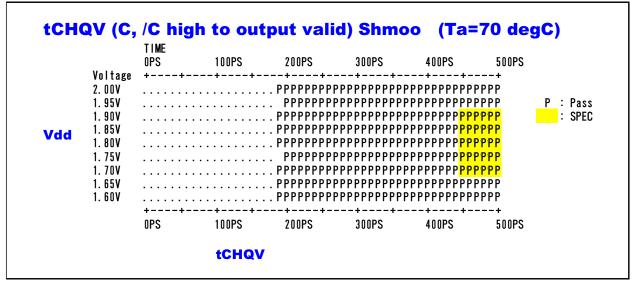
# Appendix

Example of DC/AC characteristics data

#### Parts Number : R1Q3A7218RBG-33R









# **Revision History (1)**

Rev.	Date	#	Comment
Rev. 0. 00a	<sup>'</sup> 08.10.08	π 1	Initial issue.
Rev. 0. 00b	' 08. 10. 09	1	Corrected typos in "DC Characteristics": VOH/VOL= VDDQ/2±1.12 $\rightarrow \pm 0.12$ .
			Added "Speed Bin Table".
Rev. 0. 00c	' 08. 11. 19	1	Added "ODT timing chart" to QDRII+ and DDRII+ series.
		1	Corrected typos in "General Description": ODT pin = Q0∼Qn → D0∼Dn.
			Updated "Recommended DC Operating Conditions": Vref =0.68∼0.95V → 0.7∼
Rev. 0. 00d	08.11.28	2	0.8V (11+ series).
		3	Added comment to "Thermal Resistance" section: These are reference values.
Rev. 0. 00e	'08, 12, 07		Added "Generation Number Table".
		1	Changed Marking Name in "Part Number Definition Table".
D 0. 00 £		2	Added marking information to "Package Dimension Information" section.
Rev. 0. 00 f	'09.02.09		Corrected ODT On/Off timing in "ODT pin" table.
-1			Updated minimum frequency of QDRII+ and DDRII+ series.
		5	Changed pin name in "Pin Arrangement" of DDRII+ series: SAO/SA1 $\rightarrow$ NC.
		6	Added the row to "K Truth Table": RL=2.0 and RL=2.5.
			Updated SET-UP cycles:   + series DLL lock time = 20us $ ightarrow$ 2048 cycle.
Rev. 0. 00g	' 09. 02. 24	2	Added comment to "ODT on/off Timing Chart" section: ODT on/off switching
-1	U9. UZ. Z4	2	timings are edge aligned with CQ or /CQ.
			Updated "Thermal Resistance".
<u>Rev. 0. 00h</u>	<u>' 09. 03. 04</u>	1	Added "-50" speed bin to QDR    B2 x18/x36 series.
Rev. 0. 00i	' 09. 06. 15		Updated "Package Dimensions": Mass=0.7→0.6g, A(max)=1.46→1.4mm.
1.0.0.001	03.00.13	2	Updated "Operating/Standby Supply Currents".
		1	Added comment to "Power-up and Initialization Sequence" section: Apply Vref
Rev. 0. 01a	' 09. 10. 25	-	after Vddq or at the same time as Vddq.
			Updated "Speed Bin Table".
			Added "Renesas QDR SRAM Homepage URL" to notes of front page.
			Updated "Power-up and Initialization Sequence".
Rev. 0. 02a	' 10. 02. 01	3	Updated "DLL Constraints".
		4	Updated "Operating Supply Current" and "Standby Supply Current"
			Updated "Thermal Resistance".
			Changed remarks of "AC Characteristics" on "Control signals".
			Changed company name, RENESAS logo and base color from those of Renesas Technology to Renesas Electronics.
Rev. 0. 03a	'10 0 <i>1</i> 01		Changed vender name marking in "Package Dimensions and Marking Information"
	10. 04. 01		section.
			Added "A" generation to 72M series.
			Changed the pin description for NC pin.
Rev. 0. 04a	' 10. 06. 10		Changed note 4 of "TAP Controller Instruction Set": "Clock recovery
		Z	initialization cycles are required after boundary scan"
		1	Changed Vddq range of II+ series: Vddq=1.5 $\pm$ 0.1V $\rightarrow$ 1.4V $\sim$ Vdd.
Rev. 0. 05a	' 10. 06. 25		Added Note. 8 and Note. 9 to AC Characteristics table for 11+ series.
			Updated Speed Bin Table for 144M.
Rev. 0. 05b	' 10. 07. 02	1	Added Note.2 to Generation Number Table.
1.64. 0. 030	10.07.02	2	Updated Speed Bin Table for 36M and 72M.
Rev. 0. 05c	' 10. 07. 24	1	Updated Operating Supply Current and Standby Supply Current Table for 36M
1.07. 0. 030	10.07.24		and 72M.
Rev. 0. 06a	' 10. 09. 20	1	Changed Initialization Sequence: Initial cycle of II+ series = 2048cycles
			$\rightarrow$ 20us.
<u>Rev. 0. 07a</u>	<u>' 10. 10. 06</u>	1	Added Note.9 to AC Characteristics table for 11 series.
			Updated AC Characteristics for the series of RL=2.0.
			Updated Speed Bin Table for 72M/36M/144M.
			Added R1QNA, R1QPA series to 144M QDR lineup.
	10 10 20		Changed JTAG/ID Register (ID Code):
Rev. 0. 07b	IU. IU. JU		#27="0": 36M&72M w/o ODT, 144M, 288M
		4	"1": 36M&72M w/ ODT #22="0": 144M2299M w/o ODT 25M 72M
			#23="0": 144M&288M w/o ODT, 36M, 72M
			″1″: 144M&288M w/ ODT #(26,25,24)=″100″→″101″(144M), ″101″→″110″(288M).
			[ #\∠o, ∠j, ∠4) = 100 → 101 (144M), 101 → 110 (∠ööM).



# **Revision History (2)**

Rev.	Data	#	Comment	
		1	Added Note.7 to tQVLD in AC Characteristics table for II+ series.	
		6	Changed description of tQVLD in AC Characteristics table for RL=2 series:	
Rev.0.08a	11.05.23	2	CQ high to QVLD valid $\rightarrow$ /CQ high to QVLD valid.	
Rev.0.00a	a 11.05.23	3	Updated Remarks 4 of AC Characteristics table.	
		4	Updated tKHKH(max) in AC Characteristics table for QDRII+ B2 series.	
		5	Added 13 x15 mm package lineup to 36M II+ & 72M II/II+ series.	
	11.07.17	1	Updated "Package Dimensions" for 13 x15 mm package.	
Rev.0.08b		2	Updated "Thermal Resistance" for 13 x15 mm package.	
Rev.0.060			2	Changed Title: "Ordering Information" $\rightarrow$ "Part Number Definition", "Speed
			Bin Table " $\rightarrow$ "Renesas **M QDR/DDR SRAM Lineup"	
Rev.0.09a	11.09.14	1	Updated Specification for ODT Option 2.	
Rev.0.10a	11.12.09	1	Updated Part Number Definition table.(Added Note.4)	
Rev.0.10b	12.03.12	1	Updated Part Number Definition table.(Added definition to No.10-11)	
Rev.0.10c	12.06.05	1	Updated URL for Renesas QDR SRAM Homepage.	
Rev.0.11	13.01.15	1	Updated "Part Number Definition" for 13 x 15 mm Package	



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